CDCE(L)949: Flexible Low Power LVCMOS Clock Generator With SSC Support for EMI Reduction

1 Features

- Member of programmable clock generator family
  - CDCEx913: 1 PLL, 3 outputs
  - CDCEx925: 2 PLLs, 5 outputs
  - CDCEx937: 3 PLLs, 7 outputs
  - *CDCEx949: 4 PLLs, 9 outputs*
- In-system programmability and EEPROM
  - Serial programmable volatile register
  - Nonvolatile EEPROM to store customer settings
- Flexible input clocking concept
  - External crystal: 8MHz to 32MHz
  - On-chip VCXO pull-range: ±150ppm
  - Single-ended LVCMOS up to 160MHz
- Free selectable output frequency up to 230MHz
- Low-noise PLL core
  - PLL loop filter components integrated
  - Low period jitter: 60ps (typical)
- Separate output supply pins
  - CDCE949: 3.3V and 2.5V
  - CDCEL949: 1.8V
- Flexible clock driver
  - Three user-definable control inputs [S0/S1/S2] (for example: SSC selection, frequency switching, output enable or power down)
  - Generates highly accurate clocks for video, audio, USB, IEEE1394, RFID, Bluetooth®, WLAN, Ethernet™, and GPS
  - Generates common clock frequencies used with TI-DaVinci™, OMAP™, DSPs
  - Programmable SSC modulation
  - Enables 0ppm clock generation
- 1.8V device core supply
- Wide temperature range: –40°C to 85°C
- Packaged in TSSOP
- Development and programming kit for easy PLL design and programming (TI Pro-Clock™)

2 Applications

- D-TVs
- STBs
- IP-STBs
- DVD players
- DVD recorders
- Printers

3 Description

The CDCE949 and CDCEL949 are modular PLL-based low cost, high-performance, programmable clock synthesizers, multipliers, and dividers. These devices generate up to nine output clocks from a single input frequency. Each output is programmable in-system for any clock frequency up to 230MHz, using up to four independent configurable PLLs.

The CDCEx949 has separate output supply pins (V_{DDOUT}): 1.8V for the CDCEL949 and 2.5V to 3.3V for the CDCE949.

The input accepts an external crystal or LVCMOS clock signal. If an external crystal is used, an on-chip load capacitor is adequate for most applications. The value of the load capacitor is programmable from 0pF to 20pF. Additionally, an on-chip VCXO is selectable, allowing synchronization of the output frequency to an external control signal, that is, a PWM signal.

The deep M/N divider ratio allows the generation of 0ppm audio or video, networking (WLAN, Bluetooth, Ethernet, GPS) or Interface (USB, IEEE1394, Memory Stick) clocks from a reference input frequency, such as 27MHz.

All PLLs support spread spectrum clocking (SSC). SSC can be center-spread or down-spread clocking. This is a common technique to reduce electromagnetic interference (EMI).

Based on the PLL frequency and the divider settings, the internal loop-filter components are automatically adjusted to achieve high stability, and to optimize the jitter-transfer characteristics of each PLL.

The device supports non-volatile EEPROM programming for easy customization of the device to the application. The CDCEx949 is preset to a factory-default configuration. The device can be reprogrammed to a different application configuration before PCB assembly, or reprogrammed by in-system programming. All device settings are programmable through the SDA and SCL bus, a 2-wire serial interface.
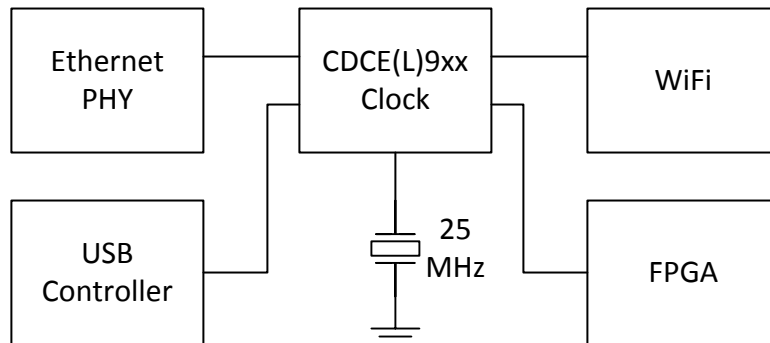
Three programmable control inputs, S0, S1 and S2, can be used to control various aspects of operation including frequency selection, changing the SSC parameters to lower EMI, PLL bypass, power down, and choosing between low level or 3-state for the output-disable function.

The CDCEx949 operates in a 1.8V environment within a temperature range of –40°C to 85°C.

Package Information

PART NUMBER	PACKAGE[1]	PACKAGE SIZE[2]
CDCE949	PW (TSSOP, 24)	7.8mm × 6.4mm
CDCEL949		

(1) For all available packages, see Section 12.
(2) The package size (length × width) is a nominal value and includes pins, where applicable.

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Typical Application Schematic

Product Folder Links: *CDCE949 CDCEL949*

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Product Folder Links: *CDCE949 CDCEL949*

4 Pin Configuration and Functions
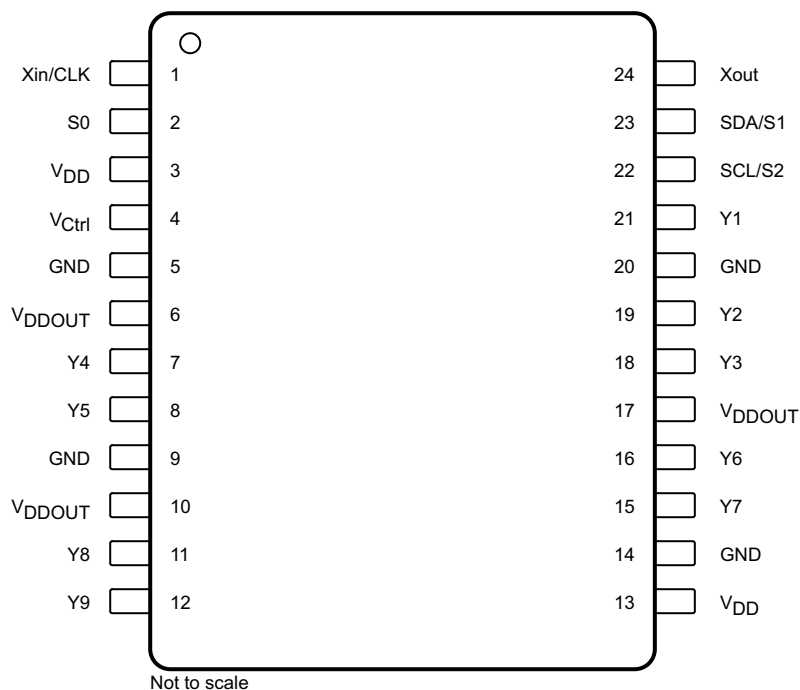
Figure 4-1. PW Package 24-Pin TSSOP (Top View)

Table 4-1. Pin Functions

PIN		TYPE[1]	DESCRIPTION
NAME	NO.		
GND	5, 9, 14, 20	G	Ground
SCL/S2	22	I	**SCL:** Serial clock input (default configuration), LVCMOS; internal pullup 500kΩ; or **S2:** User-programmable control input; LVCMOS inputs; internal pullup 500kΩ
SDA/S1	23	I/O	**SDA:** Bidirectional serial data input/output (default configuration), LVCMOS; internal pullup 500kΩ; or **S1:** User-programmable control input; LVCMOS inputs; internal pullup 500kΩ
S0	2	I	User-programmable control input S0; LVCMOS inputs; internal pullup 500kΩ
V_{Ctrl}	4	I	VCXO control voltage (leave open or pull up when not used)
V_{DD}	3, 13	P	1.8V power supply for the device
V_{DDOUT}	6, 10, 17	P	**CDCEL949:** 1.8V supply for all outputs
			CDCE949: 3.3V or 2.5V supply for all outputs
Xin/CLK	1	I	Crystal oscillator input or LVCMOS clock input (selectable through SDA/SCL bus)
Xout	24	O	Crystal oscillator output (leave open or pull up when not used)

Table 4-1. Pin Functions (continued)

PIN		TYPE[1]	DESCRIPTION
NAME	NO.		
Y1	21		
Y2	19		
Y3	18		
Y4	7		
Y5	8	O	LVCMOS output
Y6	16		
Y7	15		
Y8	11		
Y9	12		

(1)   G = Ground, I = Input, O = Output, P = Power

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Product Folder Links: *CDCE949 CDCEL949*

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)[1]

		MIN	MAX	UNIT
V_{DD}	Supply voltage	−0.5	2.5	V
V_I	Input voltage[2] [3]	−0.5	V_{DD} + 0.5	V
V_O	Output voltage[2]	−0.5	V_{DDOUT} + 0.5	V
I_I	Input current (V_I < 0, V_I > V_{DD})		20	mA
I_O	Continuous output current		50	mA
T_J	Junction temperature		125	°C
T_{stg}	Storage temperature	−65	150	°C

(1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
(2) The input and output negative voltage ratings may be exceeded if the input and output clamp–current ratings are observed.
(3) SDA and SCL can go up to 3.6V as stated in the *Recommended Operating Conditions* table.

5.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001[1]	±2000	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101[2]	±1500	

(1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

			MIN	NOM	MAX	UNIT
V_{DD}	Device supply voltage		1.7	1.8	1.9	V
$V_{DD(OUT)}$	Output Yx supply voltage	CDCE949	2.3		3.6	V
		CDCEL949	1.7		1.9	
V_{IL}	Low level input voltage LVCMOS				0.3 × V_{DD}	V
V_{IH}	High level input voltage LVCMOS		0.7 × V_{DD}			V
$V_{I(thresh)}$	Input voltage threshold LVCMOS			0.5 × V_{DD}		V
V_{IS}	Input voltage	S0	0		1.9	V
		S1, S2, SDA, SCL, $V_{Ithresh}$ = 0.5 × V_{DD}	0		3.6	
V_{ICLK}	Input voltage CLK		0		1.9	V
I_{OH} /I_{OL}	Output current	V_{DDout} = 3.3V			±12	mA
		V_{DDout} = 2.5V			±10	mA
		V_{DDout} = 1.8V			±8	mA
C_L	Output load LVCMOS				10	pF
T_A	Operating free-air temperature		−40		85	°C
CRYSTAL AND VCXO[1]						
f_{Xtal}	Crystal Input frequency (fundamental mode)		8	27	32	MHz
ESR	Effective series resistance				100	Ω
f_{PR}	Pulling (0V ≤ V_{Ctrl} ≤ 1.8V)[2]		±120	±150		ppm
$V_{(Ctrl)}$	Frequency control voltage		0		V_{DD}	V
C_0/C_1	Pullability ratio				220	

Product Folder Links: *CDCE949 CDCEL949*

		MIN	NOM	MAX	UNIT
C_L	On-chip load capacitance at Xin and Xout	0		20	pF

(1) For more information about VCXO configuration and crystal recommendation, see the *VCXO Application Guideline for CDCE(L)9xx Family* application note.

(2) Pulling range depends on crystal type, on-chip crystal load capacitance and PCB stray capacitance; pulling range of min ±120ppm applies for crystal listed in the *VCXO Application Guideline for CDCE(L)9xx Family* application note.

5.4 Thermal Information

THERMAL METRIC[2]			CDCEx949	UNIT
			PW (TSSOP)	
			24 PINS	
θ_{JA}	Junction-to-ambient thermal resistance[1]	Airflow 0 (LFM)	91	°C/W
		Airflow 150 (LFM)	75	
		Airflow 200 (LFM)	74	
		Airflow 250 (LFM)	73	
		Airflow 500 (LFM)	65	
θ_{JCtop}	Junction-to-case (top) thermal resistance		0.5	°C/W
θ_{JB}	Junction-to-board thermal resistance		52	°C/W
ψ_{JT}	Junction-to-top characterization parameter		0.5	°C/W
ψ_{JB}	Junction-to-board characterization parameter		50.1	°C/W
θ_{JCbot}	Junction-to-case (bottom) thermal resistance		50	°C/W

(1) The package thermal impedance is calculated in accordance with JESD 51 and JEDEC2S2P (high-k board).

(2) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application note.

5.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP[1]	MAX	UNIT
I_{DD}	Supply current (see Figure 5-1)	All outputs off, f_{CLK} = 27MHz, f_{VCO}= 135MHz	All PLLs on		38		mA
			Per PLL		9		
$I_{DD(OUT)}$	Supply current (see Figure 5-2 and Figure 5-3)	No load, all outputs on, f_{out} = 27MHz	CDCE949 V_{DDOUT} = 3.3V		4		mA
			CDCEL949 V_{DDOUT} = 1.8V		2		
$I_{DD(PD)}$	Power down current	Every circuit powered down except SDA/SCL, f_{IN} = 0MHz, V_{DD} = 1.9V			50		µA
$V_{(PUC)}$	Supply voltage V_{DD} threshold for power up control circuit			0.85		1.45	V
f_{VCO}	VCO frequency range of PLL			80		230	MHz
f_{OUT}	LVCMOS output frequency			230			MHz
LVCMOS							
V_{IK}	LVCMOS input voltage	V_{DD} = 1.7V, I_I = –18mA				–1.2	V
I_I	LVCMOS input current	V_I = 0V or V_{DD}, V_{DD} = 1.9V				±5	µA
I_{IH}	LVCMOS input current for S0/S1/S2	V_I = V_{DD}, V_{DD} = 1.9V				5	µA
I_{IL}	LVCMOS input current for S0/S1/S2	V_I = 0V, V_{DD} = 1.9V				–4	µA

Product Folder Links: *CDCE949 CDCEL949*

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP[1]	MAX	UNIT
C_I	Input capacitance at Xin/Clk	V_{ICLK} = 0V or V_{DD}		6		pF
	Input capacitance at Xout	V_{IXout} = 0V or V_{DD}		2		
	Input capacitance at S0/S1/S2	V_{IS} = 0V or V_{DD}		3		
CDCE949 – LVCMOS FOR V_{DDOUT} = 3.3V						
V_{OH}	LVCMOS high-level output voltage	V_{DDOUT} = 3V, I_{OH} = –0.1mA	2.9			V
		V_{DDOUT} = 3V, I_{OH} = –8mA	2.4			
		V_{DDOUT} = 3V, I_{OH} = –12mA	2.2			
V_{OL}	LVCMOS low-level output voltage	V_{DDOUT} = 3V, I_{OL} = 0.1mA			0.1	V
		V_{DDOUT} = 3V, I_{OL} = 8mA			0.5	
		V_{DDOUT} = 3V, I_{OL} = 12mA			0.8	
t_{PLH}, t_{PHL}	Propagation delay	PLL bypass		3.2		ns
t_r/t_f	Rise and fall time	V_{DDOUT} = 3.3V (20%–80%)		0.6		ns
$t_{jit(cc)}$	Cycle-to-cycle jitter[2] [3]	1 PLL switching, Y2-to-Y3		60	90	ps
		4 PLLs switching, Y2-to-Y9		120	170	
$t_{jit(per)}$	Peak-to-peak period jitter[2] [3]	1 PLL switching, Y2-to-Y3		70	100	ps
		4 PLLs switching, Y2-to-Y9		130	180	
$t_{sk(o)}$	Output skew[4]	f_{OUT} = 50MHz, Y1-to-Y3			60	ps
		f_{OUT} = 50MHz, Y2-to-Y5 or Y6-to-Y9			160	
odc	Output duty cycle[5]	f_{VCO} = 100MHz, Pdiv = 1	45%		55%	
CDCE949 – LVCMOS FOR V_{DDOUT} = 2.5V						
V_{OH}	LVCMOS high-level output voltage	V_{DDOUT} = 2.3V, I_{OH} = –0.1mA	2.2			V
		V_{DDOUT} = 2.3V, I_{OH} = –6mA	1.7			
		V_{DDOUT} = 2.3V, I_{OH} = –10mA	1.6			
V_{OL}	LVCMOS low-level output voltage	V_{DDOUT} = 2.3V, I_{OL} = 0.1mA			0.1	V
		V_{DDOUT} = 2.3V, I_{OL} = 6mA			0.5	
		V_{DDOUT} = 2.3V, I_{OL} = 10mA			0.7	
t_{PLH}, t_{PHL}	Propagation delay	PLL bypass		3.4		ns
t_r/t_f	Rise and fall time	V_{DDOUT} = 2.5V (20%–80%)		0.8		ns
$t_{jit(cc)}$	Cycle-to-cycle jitter[2] [3]	1 PLL switching, Y2-to-Y3		60	90	ps
		4 PLLs switching, Y2-to-Y9		120	170	
$t_{jit(per)}$	Peak-to-peak period jitter[2] [3]	1 PLL switching, Y2-to-Y3		70	100	ps
		4 PLLs switching, Y2-to-Y9		130	180	
$t_{sk(o)}$	Output skew[4]	f_{OUT} = 50MHz, Y1-to-Y3			60	ps
		f_{OUT} = 50MHz, Y2-to-Y5 or Y6-to-Y9			160	
odc	Output duty cycle[5]	f_{VCO} = 100MHz, Pdiv = 1	45%		55%	
CDCEL949 – LVCMOS FOR V_{DDOUT} = 1.8V						
V_{OH}	LVCMOS high-level output voltage	V_{DDOUT} = 1.7V, I_{OH} = –0.1mA	1.6			V
		V_{DDOUT} = 1.7V, I_{OH} = –4mA	1.4			
		V_{DDOUT} = 1.7V, I_{OH} = –8mA	1.1			
V_{OL}	LVCMOS low-level output voltage	V_{DDOUT} = 1.7V, I_{OL} = 0.1mA			0.1	V
		V_{DDOUT} = 1.7V, I_{OL} = 4mA			0.3	
		V_{DDOUT} = 1.7V, I_{OL} = 8mA			0.6	

Product Folder Links: *CDCE949 CDCEL949*

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP[1]	MAX	UNIT
t_{PLH}, t_{PHL}	Propagation delay	PLL bypass		2.6		ns
t_r/t_f	Rise and fall time	V_{DDOUT} = 1.8V (20%–80%)		0.7		ns
$t_{jit(cc)}$	Cycle-to-cycle jitter[2] [3]	1 PLL switching, Y2-to-Y3		70	120	ps
		4 PLLs switching, Y2-to-Y9		120	170	
$t_{jit(per)}$	Peak-to-peak period jitter[2] [3]	1 PLL switching, Y2-to-Y3		90	140	ps
		4 PLLs switching, Y2-to-Y9		130	190	
$t_{sk(o)}$	Output skew[4]	f_{OUT} = 50MHz, Y1-to-Y3			60	ps
		f_{OUT} = 50MHz, Y2-to-Y5 or Y6-to-Y9			160	
odc	Output duty cycle[5]	f_{VCO} = 100MHz, Pdiv = 1	45%		55%	
SDA AND SCL						
V_{IK}	SCL and SDA input clamp voltage	V_{DD} = 1.7V, I_I = –18mA			–1.2	V
I_{IH}	SCL and SDA input current	V_I = V_{DD}, V_{DD} = 1.9V			±10	µA
V_{IH}	SDA/SCL input high voltage[6]		0.7 × V_{DD}			V
V_{IL}	SDA/SCL input low voltage[6]				0.3 × V_{DD}	V
V_{OL}	SDA low-level output voltage	I_{OL} = 3mA, V_{DD} = 1.7V			0.2 × V_{DD}	V
C_I	SCL/SDA input capacitance	V_I = 0V or V_{DD}		3	10	pF

(1) All typical values are at respective nominal V_{DD}.
(2) 10000 cycles.
(3) Jitter depends on device configuration. Data is taken under the following conditions: 1-PLL: f_{IN} = 27MHz, Y2/3 = 27MHz, (measured at Y2), 4-PLL: f_{IN} = 27MHz, Y2/3 = 27MHz, (measured at Y2), Y4/5 = 16.384MHz, Y6/7 = 74.25MHz, Y8/9 = 48MHz.
(4) The $t_{sk(o)}$ specification is only valid for equal loading of each bank of outputs and outputs are generated from the same divider; data sampled on rising edge (t_r).
(5) odc depends on output rise- and fall-time (t_r/t_f).
(6) SDA and SCL pins are 3.3V tolerant.

5.6 EEPROM Specification

		MIN	TYP	MAX	UNIT
EEcyc	Programming cycles of EEPROM	1000			cycles
EEret	Data retention	10			years

5.7 Timing Requirements: CLK_IN

			MIN	NOM	MAX	UNIT
$f_{(CLK)}$	LVCMOS clock input frequency	PLL bypass mode	0		160	MHz
		PLL mode	8		160	
t_r / t_f	Rise and fall time CLK signal (20% to 80%)				3	ns
$duty_{CLK}$	Duty cycle CLK at V_{DD} / 2		40%		60%	

5.8 Timing Requirements: SDA/SCL

over operating free-air temperature range (unless otherwise noted; see Figure 7-9)

			MIN	NOM	MAX	UNIT
$f_{(SCL)}$	SCL clock frequency	Standard mode	0		100	kHz
		Fast mode	0		400	
$t_{su(START)}$	START setup time (SCL high before SDA low)	Standard mode	4.7			µs
		Fast mode	0.6			

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Product Folder Links: *CDCE949 CDCEL949*

over operating free-air temperature range (unless otherwise noted; see Figure 7-9)

			MIN	NOM	MAX	UNIT
$t_{h(START)}$	START hold time (SCL low after SDA low)	Standard mode	4			μs
		Fast mode	0.6			
$t_{w(SCLL)}$	SCL low-pulse duration	Standard mode	4.7			μs
		Fast mode	1.3			
$t_{w(SCLH)}$	SCL high-pulse duration	Standard mode	4			μs
		Fast mode	0.6			
$t_{h(SDA)}$	SDA hold time (SDA valid after SCL low)	Standard mode	0		3.45	μs
		Fast mode	0		0.9	
$t_{su(SDA)}$	SDA setup time	Standard mode	250			ns
		Fast mode	100			
t_r	SCL/SDA input rise time	Standard mode			1000	ns
		Fast mode			300	
t_f	SCL/SDA input fall time				300	ns
$t_{su(STOP)}$	STOP setup time	Standard mode	4			μs
		Fast mode	0.6			
t_{BUF}	Bus free time between a STOP and START condition	Standard mode	4.7			μs
		Fast mode	1.3			

Product Folder Links: *CDCE949 CDCEL949*

5.9 Typical Characteristics
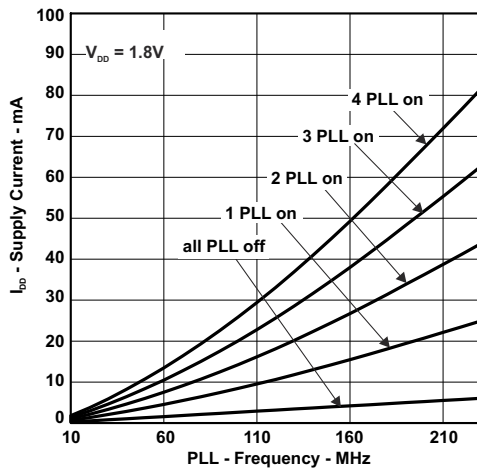
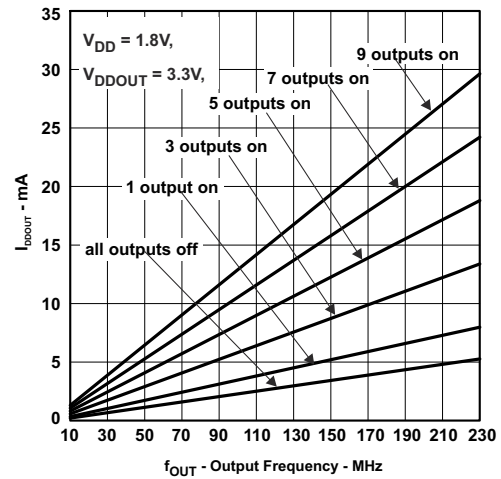**Figure 5-1. CDCEx949 Supply Current vs PLL Frequency**
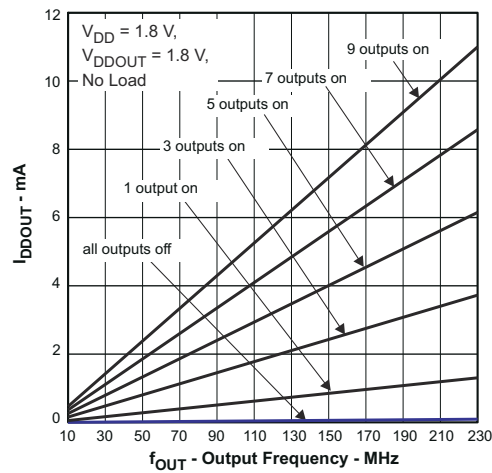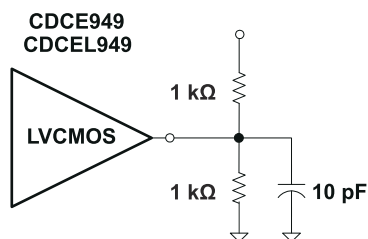

Figure 5-2. CDCE949 Output Current vs Output Frequency

Figure 5-3. CDCEL949 Output Current vs Output Frequency

6 Parameter Measurement Information

**CDCE949
CDCEL949**

LVCMOS

1 kΩ

1 kΩ   10 pF

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Figure 6-1. Test Load

**CDCE949
CDCEL949**

LVCMOS

**Series
Termination
18Ω**

**Line Impedance
Zo = 50Ω**

LVCMOS

**Typical Driver
Impedance
32Ω**
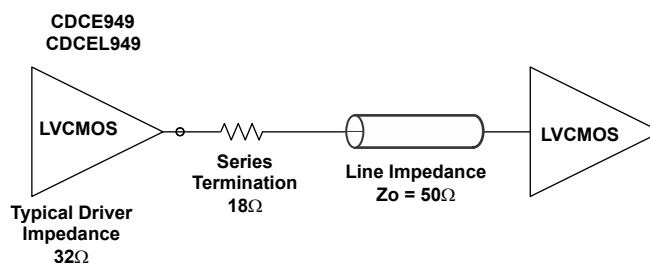
Figure 6-2. Test Load for 50Ω Board Environment

Product Folder Links: *CDCE949 CDCEL949*

7 Detailed Description

7.1 Overview

The CDCE949 and CDCEL949 devices are modular PLL-based, low-cost, high-performance, programmable clock synthesizers, multipliers, and dividers. The devices generate up to nine output clocks from a single input frequency. Each output is programmable in-system for any clock frequency up to 230MHz, using one of the four integrated configurable PLLs.

The CDCEx949 has separate output supply pins, V_{DDOUT}, which is 1.8V for CDCEL949 and 2.5V to 3.3V for CDCE949.

The input accepts an external crystal or LVCMOS clock signal. If an external crystal is used, an on-chip load capacitor is adequate for most applications. The value of the load capacitor is programmable from 0pF to 20 pF. Additionally, a selectable on-chip VCXO allows for synchronization of the output frequency to an external control signal, that is, the PWM signal.

The deep M/N divider ratio allows the generation of 0ppm audio and video, networking (WLAN, Bluetooth, Ethernet, GPS), or Interface (USB, IEEE1394, memory stick) clocks from a reference input frequency such as 27MHz.

All PLLs support spread-spectrum clocking (SSC). SSC can be center-spread or down-spread clocking. This is a common technique to reduce electro-magnetic interference (EMI).

Based on the PLL frequency and the divider settings, the internal loop filter components are automatically adjusted to achieve high stability, and to optimize the jitter-transfer characteristics of each PLL.

The device supports non-volatile EEPROM programming for easy customization of the device to the application. The internal EEPROM of the CDCEx949 is preset to a factory-default configuration (see *Default Device Setting*). The EEPROM can be reprogrammed to a different application configuration before PCB assembly, or reprogrammed by in-system programming. All device settings are programmable through the SDA and SCL bus, a 2-wire serial interface.

Use the three programmable control inputs, S0, S1 and S2, to control various aspects of operation including frequency selection, changing the SSC parameters to lower EMI, PLL bypass, power down, and choosing between low level or 3-state for the output-disable function.

The CDCEx949 operates in a 1.8V environment within a temperature range of –40°C to 85°C.

7.2 Functional Block Diagram
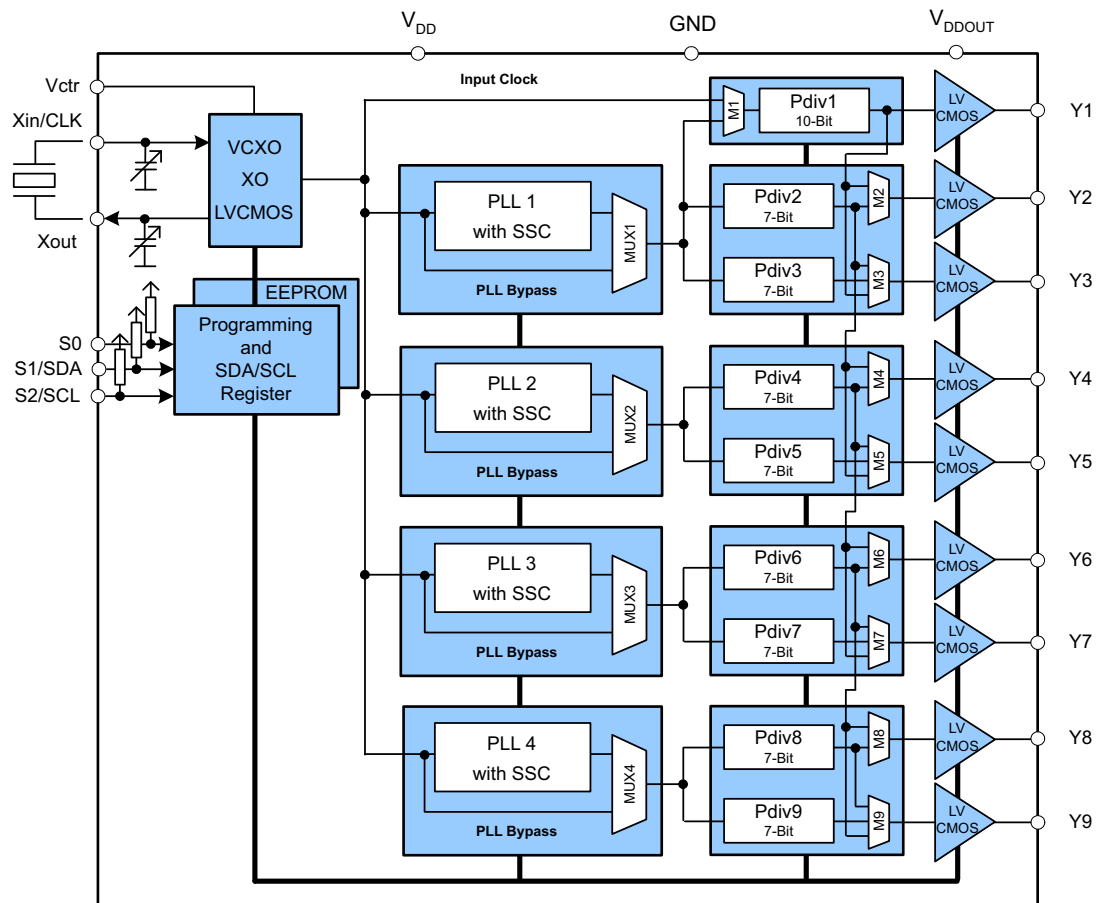
7.3 Feature Description

7.3.1 Control Terminal Setting

The CDCEx949 has three user-definable control terminals (S0, S1, and S2) which allow external control of device settings. The user-definable control terminals can be programmed to any of the following setting:

- Spread spectrum clocking selection → spread type and spread amount selection
- Frequency selection → switching between any of two user-defined frequencies
- Output state selection → output configuration and power down control

The user can predefine up to eight different control settings. Table 7-1 and Table 7-2 provide these settings.

Table 7-1. Control Terminal Definition

EXTERNAL CONTROL BITS	PLL1 SETTING			PLL2 SETTING			PLL3 SETTING			PLL4 SETTING			Y1 SETTING
Control Function	PLL Frequency Selection	SSC Selection	Output Y2/Y3 Selection	PLL Frequency Selection	SSC Selection	Output Y4/Y5 Selection	PLL Frequency Selection	SSC Selection	Output Y6/Y7 Selection	PLL Frequency Selection	SSC Selection	Output Y8/Y9 Selection	Output Y1 and Power Down Selection

Table 7-2. PLLx Setting (Can Be Selected for Each PLL Individual)

SSC SELECTION (CENTER/DOWN)[1]				
SSCx [3-bits]			CENTER	DOWN
0	0	0	0% (off)	0% (off)
0	0	1	±0.25%	−0.25%

Product Folder Links: *CDCE949 CDCEL949*

Table 7-2. PLLx Setting (Can Be Selected for Each PLL Individual) (continued)

SSC SELECTION (CENTER/DOWN)[1]				
SSCx [3-bits]			CENTER	DOWN
0	1	0	±0.5%	−0.5%
0	1	1	±0.75%	−0.75%
1	0	0	±1%	−1%
1	0	1	±1.25%	−1.25%
1	1	0	±1.5%	−1.5%
1	1	1	±2%	−2%
FREQUENCY SELECTION[2]				
FSx		FUNCTION		
0		Frequency0		
1		Frequency1		
OUTPUT SELECTION[3] (Y2 ... Y9)				
YxYx		FUNCTION		
0		State0		
1		State1		

(1) Center/Down-Spread, Frequency0/1 and State0/1 are user-definable in PLLx Configuration Register
(2) Frequency0 and Frequency1 can be any frequency within the specified f_{VCO} range
(3) State0/1 selection is valid for both outputs of the corresponding PLL module and can be power down, 3-state, low, or active

Table 7-3. Y1 Setting [1]

Y1 SELECTION	
Y1	FUNCTION
0	State 0
1	State 1

(1) State0 and State1 are user definable in Generic Configuration Register and can be power down, 3-state, low, or active.

S1/SDA and S2/SCL pins of the CDCEx949 are dual function pins. In default configuration they are defined as SDA/SCL for the serial interface. They can be programmed as control-pins (S1/S2) by setting the relevant bits in the EEPROM. Note that the changes to the Control register (Bit [6] of Byte [02]) have no effect until they are written into the EEPROM.

Once they are set as control pins, the serial programming interface is no longer available. However, if V_{DDOUT} is forced to GND, the two control-pins, S1 and S2, temporally act as serial programming pins (SDA/SCL).

S0 is not a multiuse pin and is a control pin only.

7.3.2 Default Device Setting

Figure 7-1 shows the preconfiguration (the input frequency is passed through to the output as a default) of the internal EEPROM of CDCEx949. This preconfiguration allows the device to operate in default mode without the extra production step of programming. The default setting appears after power is supplied or after power-down or power-up sequence until the setting is re-programmed by the user to a different application configuration. A new register setting is programmed through the serial SDA/SCL Interface.
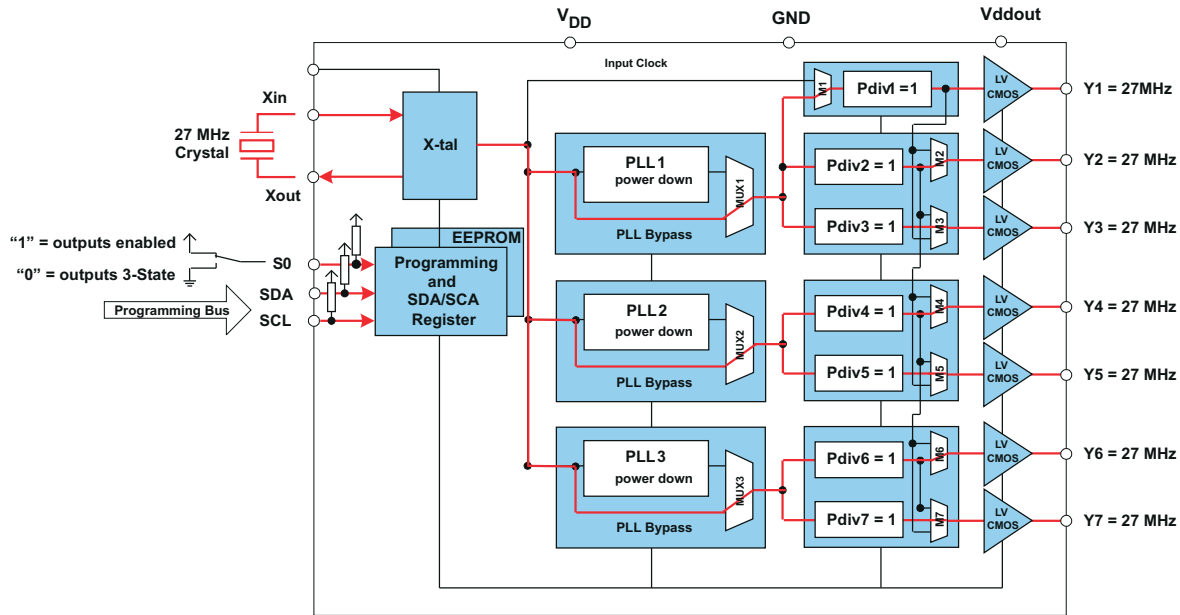
Figure 7-1. Default Device Setting

Table 7-4 shows the factory default setting for the Control Terminal Register (external control pins). In normal operation, all 8 register settings are available, but in the default configuration only the first two settings (0 and 1) can be selected with S0, as S1 and S2 configured as programming pins in default mode.

Table 7-4. Factory Default Setting for Control Terminal Register

			Y1	PLL1 SETTING			PLL2 SETTING			PLL3 SETTING			PLL3 SETTING		
EXTERNAL CONTROL PINS[1]			OUTPUT SELECT	FREQ. SELECT	SSC SEL.	OUTPUT SELECT	FREQ. SELECT	SSC SEL.	OUTPUT SELECT	FREQ. SELECT	SSC SEL.	OUTPUT SELECT	FREQ. SELECT	SSC SEL.	OUTPUT SELECT
S2	S1	S0	Y1	FS1	SSC1	Y2Y3	FS2	SSC2	Y4Y5	FS3	SSC3	Y6Y7	FS4	SSC4	Y8Y9
SCL (I^2C)	SDA (I^2C)	0	3-state	f_{VCO1_0}	off	3-state	f_{VCO2_0}	off	3-state	f_{VCO3_0}	off	3-state	f_{VCO4_0}	off	3-state
SCL (I^2C)	SDA (I^2C)	1	enabled	f_{VCO1_0}	off	enabled	f_{VCO2_0}	off	enabled	f_{VCO3_0}	off	enabled	f_{VCO4_0}	off	enabled

(1) In default mode or when programmed respectively, S1 and S2 act as serial programming interface, SDA/SCL. They do not have any control-pin function but they are internally interpreted as if S1 = 0 and S2 = 0. However, S0 is a control-pin which in the default mode switches all outputs ON or OFF (as previously predefined).

7.3.3 SDA/SCL Serial Interface

The CDCEx949 operates as a target device of the 2-wire serial SDA/SCL bus, compatible with the popular *SMBus* or *I^2C Bus* specification. The device operates in the standard-mode transfer (up to 100kbps) and fast-mode transfer (up to 400kbps) and supports 7-bit addressing.

The S1/SDA and S2/SCL pins of the CDCEx949 are dual function pins. In the default configuration the S1/SDA and S2/SCL pins are used as SDA/SCL serial programming interface. The S1/SDA and S2/SCL pins can be re-programmed as general-purpose control pins, S1 and S2, by changing the corresponding EEPROM setting, Byte 02, Bit [6].
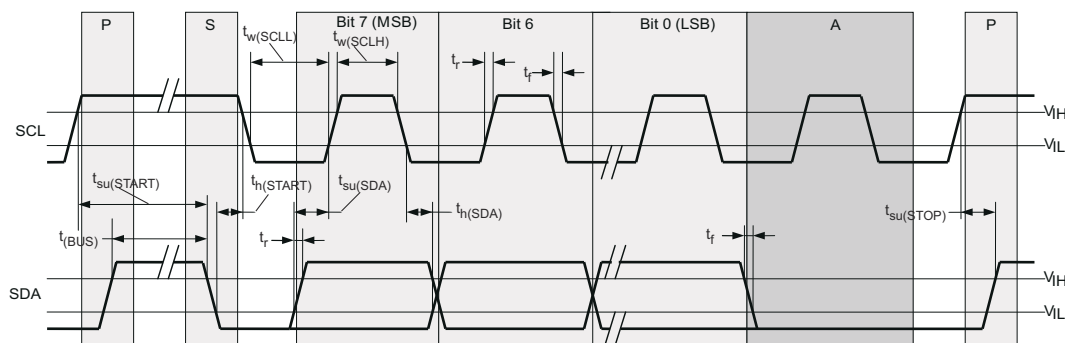
Product Folder Links: *CDCE949 CDCEL949*

Figure 7-2. Timing Diagram for SDA/SCL Serial Control Interface

7.3.4 Data Protocol

The device supports *Byte Write and Byte Read* and *Block Write and Block Read* operations.

For *Byte Write/Read* operations, the system controller individually accesses addressed bytes.

For *Block Write/Read* operations, the bytes are accessed in sequential order from lowest to highest byte (with most significant bit first) with the ability to stop after any complete byte has been transferred. The numbers of bytes read-out are defined by Byte Count in the Generic Configuration Register. At Block Read instruction, all bytes defined in the Byte Count have to be readout to correctly finish the read cycle.

After a byte is sent, the byte is written into the internal register and is effective immediately. This applies to each transferred byte, independent of whether this is a *Byte Write* or a *Block Write* sequence.

If the EEPROM Write Cycle is initiated, the internal SDA register contents are written into the EEPROM. During this write cycle, data is not accepted at the SDA/SCL bus until the write cycle is completed. However, data can be read during the programming sequence (Byte Read or Block Read). Read *EEPIP*, Byte 01–Bit [6] to monitor the programming status. Before beginning EEPROM programming, pull CLKIN LOW. CLKIN must be held LOW for the duration of EEPROM programming. After initiating EEPROM programming with EEWRITE, byte 06h-bit 0, do not write to the device registers until EEPIP is read back as a 0.

The offset of the indexed byte is encoded in the command code, as described in Table 7-5.

Table 7-5. Target Receiver Address (7 Bits)

DEVICE	A6	A5	A4	A3	A2	A1[1]	A0[1]	R/$\overline{W}$
CDCEx913	1	1	0	0	1	0	1	1/0
CDCEx925	1	1	0	0	1	0	0	1/0
CDCEx937	1	1	0	1	1	0	1	1/0
CDCEx949	1	1	0	1	1	0	0	1/0

(1)   Address bits A0 and A1 are programmable through the SDA/SCL bus (Byte 01, Bit [1:0]). This allows addressing up to 4 devices connected to the same SDA/SCL bus. The least-significant bit of the address byte designates a write or read operation.

7.4 Device Functional Modes

7.4.1 SDA/SCL Hardware Interface

Figure 7-3 shows how the CDCEx949 clock synthesizer is connected to the SDA/SCL serial interface bus. Multiple devices can be connected to the bus but the speed may need to be reduced (400kHz is the maximum) if many devices are connected.

Note that the pullup resistor value (R_P) depends on the supply voltage, bus capacitance and number of connected devices. The recommended pullup value is 4.7kΩ. The value must meet the minimum sink current of 3mA at V_{OLmax} = 0.4V for the output stages (for more details, see *SMBus* or *I²C Bus* specification).
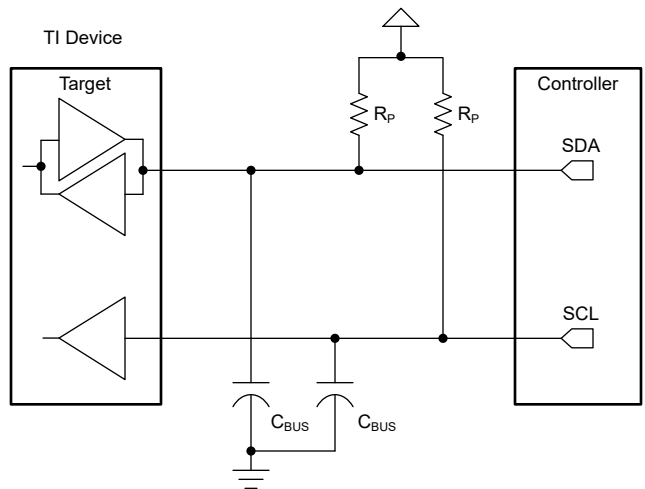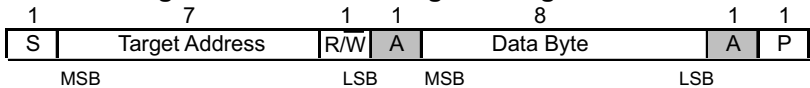
Figure 7-3. SDA/SCL Hardware Interface

7.5 Programming

Table 7-6. Command Code Definition

BIT	DESCRIPTION
7	0 = *Block Read* or *Block Write* operation 1 = *Byte Read* or *Byte Write* operation
(6:0)	Byte Offset for *Byte Read*, *Block Read*, *Byte Write* and *Block Write* operation.

Figure 7-4. Generic Programming

	1	7	1	1	8	1	1
	S	Target Address	R/W	A	Data Byte	A	P
		MSB	LSB	MSB		LSB	

S	Start Condition
Sr	Repeated Start Condition
R/W	1 = Read (Rd) From CDCE9xx Device; 0 = Write (Wr) to CDCE9xxx
A	Acknowledge (ACK = 0 and NACK =1)
P	Stop Condition
	Controller-to-Target Transmission
Sequence	Target-to-Controller Transmission

1	7	1	1	8	1	8	1	1
S	Target Address	Wr	A	CommandCode	A	Data Byte	A	P
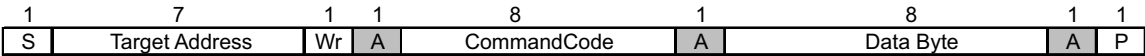
Figure 7-5. Byte Write Protocol

1	7	1	1	8	1	1	7	1	1
S	Target Address	Wr	A	CommandCode	A	Sr	Target Address	Rd	A

8	1	1
Data Byte	A	P

Figure 7-6. Byte Read Protocol

Product Folder Links: *CDCE949 CDCEL949*

1	7	1	1	8	1	8	1
S	Target Address	Wr	A	CommandCode	A	Byte Count = N	A

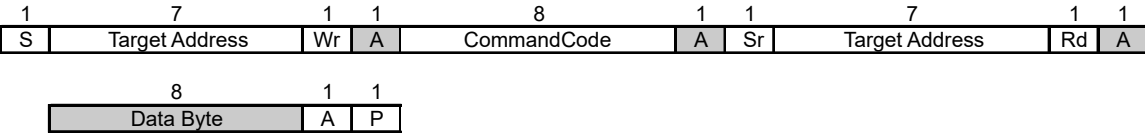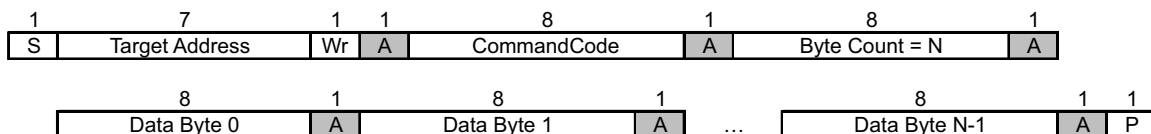| 8	1	8	1		8	1	1
Data Byte 0	A	Data Byte 1	A	…	Data Byte N-1	A	P

Data Byte 0 Bits [7:0] are reserved for Revision Code and Vendor Identification. The Data Byte 0 is used for internal test purpose and must not be overwritten.
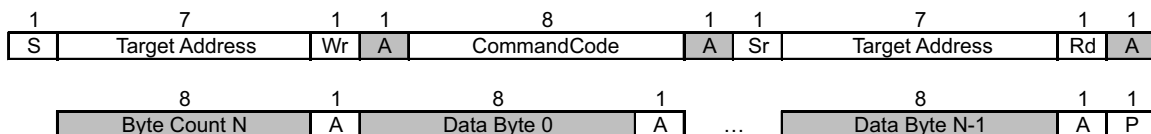
Figure 7-7. Block Write Programming

1	7	1	1	8	1	1	7	1	1
S	Target Address	Wr	A	CommandCode	A	Sr	Target Address	Rd	A

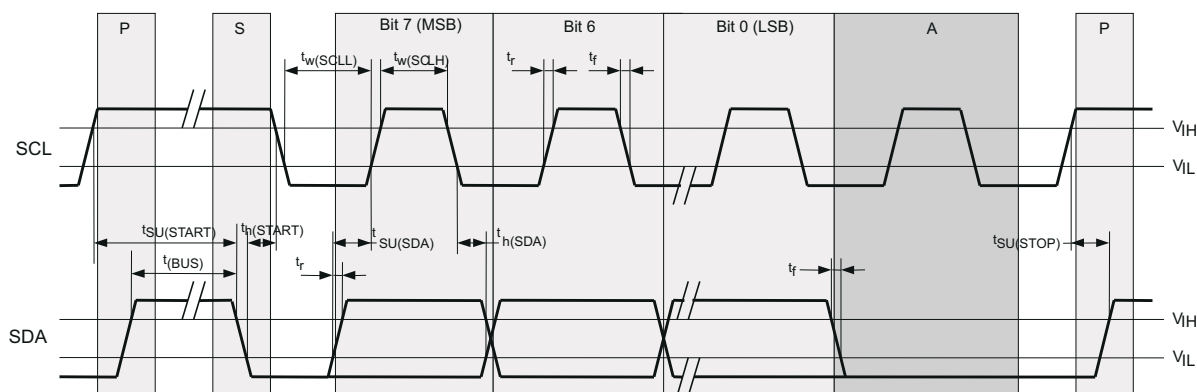| 8	1	8	1		8	1	1
Byte Count N	A	Data Byte 0	A	…	Data Byte N-1	A	P

Figure 7-8. Block Read Protocol

Figure 7-9. Timing Diagram for the SDA/SCL Serial Control Interface

8 Register Maps

8.1 SDA/SCL Configuration Registers

The clock input, control pins, PLLs, and output stages are user configurable. The following tables and explanations describe the programmable functions of the CDCEx949. All settings can be manually written to the device through the SDA/SCL bus, or are easily programmable by using the TI Pro Clock software. TI Pro Clock software allows the user to quickly make all settings and automatically calculates the values for optimized performance at lowest jitter.

Table 8-1. SDA/SCL Registers

ADDRESS OFFSET	REGISTER DESCRIPTION	TABLE
00h	Generic configuration register	Table 8-3
10h	PLL1 configuration register	Table 8-4
20h	PLL2 configuration register	Table 8-5
30h	PLL3 configuration register	Table 8-6
40h	PLL4 configuration register	Table 8-7

The grey-highlighted Bits described in the configuration registers tables on the following pages, belong to the Control Pin Register. The user can predefine up to eight different control settings. These settings can then be selected by the external control pins, S0, S1, and S2 (see *Control Terminal Setting*).

Table 8-2. Configuration Register, External Control Pins

| EXTERNAL CONTROL PINS			Y1 OUTPUT SELECT	PLL1 SETTING			PLL2 SETTING			PLL3 SETTING			PLL4 SETTING		
				FREQ SELECT	SSC SELECT	OUTPUT SELECT	FREQ SELECT	SSC SELECT	OUTPUT SELECT	FREQ SELECT	SSC SELECT	OUTPUT SELECT	FREQ SELECT	SSC SELECT	OUTPUT SELECT
S2	S1	S0	Y1	FS1	SSC1	Y2Y3	FS2	SSC2	Y4Y5	FS3	SSC3	Y6Y7	FS4	SSC4	Y8Y9
0	0	0	Y1_0	FS1_0	SSC1_0	Y2Y3_0	FS2_0	SSC2_0	Y4Y5_0	FS3_0	SSC3_0	Y6Y7_0	FS4_0	SSC4_0	Y8Y9_0
0	0	1	Y1_1	FS1_1	SSC1_1	Y2Y3_1	FS2_1	SSC2_1	Y4Y5_1	FS3_1	SSC3_1	Y6Y7_1	FS4_1	SSC4_1	Y8Y9_1
0	1	0	Y1_2	FS1_2	SSC1_2	Y2Y3_2	FS2_2	SSC2_2	Y4Y5_2	FS3_2	SSC3_2	Y6Y7_2	FS4_2	SSC4_2	Y8Y9_2
0	1	1	Y1_3	FS1_3	SSC1_3	Y2Y3_3	FS2_3	SSC2_3	Y4Y5_3	FS3_3	SSC3_3	Y6Y7_3	FS4_3	SSC4_3	Y8Y9_3
1	0	0	Y1_4	FS1_4	SSC1_4	Y2Y3_4	FS2_4	SSC2_4	Y4Y5_4	FS3_4	SSC3_4	Y6Y7_4	FS4_4	SSC4_4	Y8Y9_4
1	0	1	Y1_5	FS1_5	SSC1_5	Y2Y3_5	FS2_5	SSC2_5	Y4Y5_5	FS3_5	SSC3_5	Y6Y7_5	FS4_5	SSC4_5	Y8Y9_5
1	1	0	Y1_6	FS1_6	SSC1_6	Y2Y3_6	FS2_6	SSC2_6	Y4Y5_6	FS3_6	SSC3_6	Y6Y7_6	FS4_6	SSC4_6	Y8Y9_6
1	1	1	Y1_7	FS1_7	SSC1_7	Y2Y3_7	FS2_7	SSC2_7	Y4Y5_7	FS3_7	SSC3_7	Y6Y7_7	FS4_7	SSC4_7	Y8Y9_7
Address Offset[1]			04h	13h	10h-12h	15h	23h	20h-22h	25h	33h	30h-32h	35h	43h	40h-42h	45h

(1) Address offset refers to the byte address in the configuration register on following pages.

Table 8-3. Generic Configuration Register

OFFSET[1]	BIT[2]	ACRONYM	DEFAULT[3]	DESCRIPTION	
00h	7	E_EL	xb	Device Identification (read only): '1' is CDCE949 (3.3V), '0' is CDCEL949 (1.8V)	
	6:4	RID	Xb	Revision Identification Number (read only)	
	3:0	VID	1h	Vendor Identification Number (read only)	
01h	7	–	0b	Reserved - always write 0	
	6	EEPIP	0b	EEPROM Programming Status[4]: (read only)	0 – EEPROM programming is completed 1 – EEPROM is in programming mode
	5	EELOCK	0b	Permanently Lock EEPROM Data[5]:	0 – EEPROM is not locked 1 – EEPROM is permanently locked
	4	PWDN	0b	Device power down (overwrites S0/S1/S2 setting; configuration register settings are unchanged) Note: PWDN cannot be set to 1 in the EEPROM. 0 – device active (all PLLs and all outputs are enabled) 1 – device power down (all PLLs in power down and all outputs in 3-State)	
	3:2	INCLK	00b	Input clock selection:	00 – X-tal 10 – LVCMOS 01 – VCXO 11 – reserved
	1:0	TARGET_ADR	00b	Programmable Address Bits A0 and A1 of the Target Receiver Address	

Product Folder Links: *CDCE949 CDCEL949*

Table 8-3. Generic Configuration Register (continued)

OFFSET[1]	BIT[2]	ACRONYM	DEFAULT[3]	DESCRIPTION
02h	7	M1	1b	Clock source selection for output Y1: 0 – input clock 1 – PLL1 clock
	6	SPICON	0b	Operation mode selection for pin 22/23[6] 0 – serial programming interface SDA (pin 23) and SCL (pin 22) 1 – control pins S1 (pin 23) and S2 (pin 22)
	5:4	Y1_ST1	11b	Y1-State0/1 Definition (applies to Y1_ST1 and Y1_ST0)
	3:2	Y1_ST0	01b	00 – device power down (all PLLs in power down and all outputs in 3-state) 01 – Y1 disabled to 3-state 10 – Y1 disabled to low 11 – Y1 enabled (normal operation)
	1:0	Pdiv1 [9:8]	001h	10-Bit Y1-Output-Divider 0 – divider reset and stand-by Pdiv1: 1-to-1023 – divider value
03h	7:0	Pdiv1 [7:0]		
04h	7	Y1_7	0b	Y1_x State Selection[7]
	6	Y1_6	0b	
	5	Y1_5	0b	
	4	Y1_4	0b	
	3	Y1_3	0b	0 – State0 (predefined by Y1-State0 Definition [Y1_ST0]) 1 – State1 (predefined by Y1-State1 Definition [Y1_ST1])
	2	Y1_2	0b	
	1	Y1_1	1b	
	0	Y1_0	0b	
05h	7:3	XCSEL	0Ah	Crystal load capacitor selection[8]: 00h → 0pF 01h → 1pF 02h → 2pF 14h-to-1Fh → 20pF
	2:0	—	0b	Reserved - do not write others than 0
06h	7:1	BCOUNT	50h	7-Bit Byte Count (Defines the number of Bytes which is sent from this device at the next Block Read transfer; all bytes must be read out to correctly finish the read cycle.)
	0	EEWRITE	0b	Initiate EEPROM Write Cycle[4] [9] 0 – no EEPROM write cycle 1 – start EEPROM write cycle (internal configuration register is saved to the EEPROM)
07h-0Fh	—	—	0h	Reserved – do not write others than 0
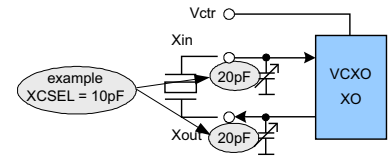
(1) Writing data beyond 50h may adversely affect device function.
(2) All data is transferred MSB-first.
(3) Unless custom setting is used.
(4) During EEPROM programming, no data is allowed to be sent to the device through the SDA/SCL bus until the programming sequence is completed. Data, however, can be read during the programming sequence (Byte Read or Block Read).
(5) If this bit is set high in the EEPROM, the actual data in the EEPROM is permanently locked, and no further programming is possible. Data, however can still be written through the SDA/SCL bus to the internal register to change device function on the fly. But new data can no longer be saved to the EEPROM. EELOCK is effective only if written into the EEPROM
(6) Selection of *control-pins* is effective only if written into the EEPROM. Once written into the EEPROM, the serial programming pins are no longer available. However, if V_{DDOUT} is forced to GND, the two control-pins, S1 and S2, temporally act as serial programming pins (SDA/SCL), and the two target receiver address bits are reset to A0 = 0 and A1 = 0.
(7) These are the bits of the Control Pin Register. The user can predefine up to eight different control settings. These settings can then be selected by the external control pins, S0, S1, and S2.
(8) The internal load capacitor (C_1, C_2) must be used to achieve the best clock performance. External capacitors must be used only to do a fine adjustment of C_L by few pF. The value of C_L can be programmed with a resolution of 1pF for a total crystal load range of 0pF to 20pF. For C_L > 20pF use additional external capacitors. Also, the device input capacitance must be considered; this adds 1.5pF (6pF, 2pF) to the selected C_L. For more information about VCXO configuration and crystal recommendations, see *VCXO Application Guideline for CDCE(L)9xx Family* (SCAA085).
(9) NOTE: The EEPROM WRITE bit must be sent last to make sure the contents of all internal registers are written into the EEPROM. The EEWRITE cycle is initiated by the rising edge of the EEWRITE-Bit. A static level high does not trigger an EEPROM WRITE cycle. The EEWRITE-Bit must be reset low after the programming is completed. The programming status can be monitored by readout EEPIP. If EELOCK is set high, no EEPROM programming is possible.

Table 8-4. PLL1 Configuration Register

OFFSET[1]	BIT[2]	ACRONYM	DEFAULT[3]	DESCRIPTION
10h	7:5	SSC1_7 [2:0]	000b	SSC1: PLL1 SSC Selection (Modulation Amount)[4]
	4:2	SSC1_6 [2:0]	000b	
	1:0	SSC1_5 [2:1]	000b	**Down** **Center**
11h	7	SSC1_5 [0]		000 (off) 000 (off)
	6:4	SSC1_4 [2:0]	000b	001 – 0.25% 001 ± 0.25%
	3:1	SSC1_3 [2:0]	000b	010 – 0.5% 010 ± 0.5%
	0	SSC1_2 [2]	000b	011 – 0.75% 011 ± 0.75%
12h	7:6	SSC1_2 [1:0]		100 – 1.0% 100 ± 1.0%
	5:3	SSC1_1 [2:0]	000b	101 – 1.25% 101 ± 1.25%
	2:0	SSC1_0 [2:0]	000b	110 – 1.5% 110 ± 1.5% 111 – 2.0% 111 ± 2.0%
13h	7	FS1_7	0b	FS1_x: PLL1 Frequency Selection[4]
	6	FS1_6	0b	
	5	FS1_5	0b	
	4	FS1_4	0b	
	3	FS1_3	0b	0 – f_{VCO1_0} (predefined by PLL1_0 – Multiplier/Divider value)
	2	FS1_2	0b	1 – f_{VCO1_1} (predefined by PLL1_1 – Multiplier/Divider value)
	1	FS1_1	0b	
	0	FS1_0	0b	
14h	7	MUX1	1b	PLL1 Multiplexer: 0 – PLL1 1 – PLL1 Bypass (PLL1 is in power down)
	6	M2	1b	Output Y2 Multiplexer: 0 – Pdiv1 1 – Pdiv2
	5:4	M3	10b	Output Y3 Multiplexer: 00 – Pdiv1-Divider 01 – Pdiv2-Divider 10 – Pdiv3-Divider 11 – reserved
	3:2	Y2Y3_ST1	11b	Y2, Y3-State0/1definition: 00 – Y2/Y3 disabled to 3-State (PLL1 is in power down) 01 – Y2/Y3 disabled to 3-State (PLL1 on) 10 – Y2/Y3 disabled to low (PLL1 on) 11 – Y2/Y3 enabled (normal operation, PLL1 on)
	1:0	Y2Y3_ST0	01b	
15h	7	Y2Y3_7	0b	Y2Y3_x Output State Selection[4]
	6	Y2Y3_6	0b	
	5	Y2Y3_5	0b	
	4	Y2Y3_4	0b	0 – state0 (predefined by Y2Y3_ST0)
	3	Y2Y3_3	0b	1 – state1 (predefined by Y2Y3_ST1)
	2	Y2Y3_2	0b	
	1	Y2Y3_1	1b	
	0	Y2Y3_0	0b	
16h	7	SSC1DC	0b	PLL1 SSC down/center selection: 0 – down 1 – center
	6:0	Pdiv2	01h	7-Bit Y2-Output-Divider Pdiv2: 0 – reset and stand-by 1-to-127 – divider value
17h	7	—	0b	Reserved – do not write others than 0
	6:0	Pdiv3	01h	7-Bit Y3-Output-Divider Pdiv3: 0 – reset and stand-by 1-to-127 – divider value

Product Folder Links: *CDCE949 CDCEL949*

Table 8-4. PLL1 Configuration Register (continued)

OFFSET[1]	BIT[2]	ACRONYM	DEFAULT[3]	DESCRIPTION
18h	7:0	PLL1_0N [11:4]	004h	PLL1_0[5]: 30-Bit Multiplier/Divider value for frequency f_{VCO1_0} (for more information, see *PLL Frequency Planning*)
19h	7:4	PLL1_0N [3:0]	004h	
	3:0	PLL1_0R [8:5]	000h	
1Ah	7:3	PLL1_0R[4:0]	000h	
	2:0	PLL1_0Q [5:3]	10h	
1Bh	7:5	PLL1_0Q [2:0]	10h	
	4:2	PLL1_0P [2:0]	010b	
	1:0	VCO1_0_RANGE	00b	f_{VCO1_0} range selection: 00 – f_{VCO1_0} < 125MHz 01 – 125MHz ≤ f_{VCO1_0} < 150MHz 10 – 150MHz ≤ f_{VCO1_0} < 175MHz 11 – f_{VCO1_0} ≥ 175MHz
1Ch	7:0	PLL1_1N [11:4]	004h	PLL1_1[5]: 30-bit Multiplier/Divider value for frequency f_{VCO1_1} (for more information, see *PLL Frequency Planning*).
1Dh	7:4	PLL1_1N [3:0]	004h	
	3:0	PLL1_1R [8:5]	000h	
1Eh	7:3	PLL1_1R[4:0]	000h	
	2:0	PLL1_1Q [5:3]	10h	
1Fh	7:5	PLL1_1Q [2:0]	10h	
	4:2	PLL1_1P [2:0]	010b	
	1:0	VCO1_1_RANGE	00b	f_{VCO1_1} range selection: 00 – f_{VCO1_1} < 125MHz 01 – 125MHz ≤ f_{VCO1_1} < 150MHz 10 – 150MHz ≤ f_{VCO1_1} < 175MHz 11 – f_{VCO1_1} ≥ 175MHz

(1)   Writing data beyond 50h may adversely affect device function.
(2)   All data is transferred MSB-first.
(3)   Unless a custom setting is used
(4)   The user can predefine up to eight different control settings. In normal device operation, these settings can be selected by the external control pins, S0, S1, and S2.
(5)   PLL settings limits: 16 ≤ q ≤ 63, 0 ≤ p ≤ 7, 0 ≤ r ≤ 511, 0 < N < 4096

Table 8-5. PLL2 Configuration Register

OFFSET[1]	BIT[2]	ACRONYM	DEFAULT[3]	DESCRIPTION
20h	7:5	SSC2_7 [2:0]	000b	SSC2: PLL2 SSC Selection (Modulation Amount)[4]
	4:2	SSC2_6 [2:0]	000b	
	1:0	SSC2_5 [2:1]	000b	**Down** **Center** 000 (off) 000 (off)
21h	7	SSC2_5 [0]	000b	001 – 0.25% 001 ± 0.25%
	6:4	SSC2_4 [2:0]	000b	010 – 0.5% 010 ± 0.5%
	3:1	SSC2_3 [2:0]	000b	011 – 0.75% 011 ± 0.75%
	0	SSC2_2 [2]	000b	100 – 1.0% 100 ± 1.0% 101 – 1.25% 101 ± 1.25%
22h	7:6	SSC2_2 [1:0]	000b	110 – 1.5% 110 ± 1.5%
	5:3	SSC2_1 [2:0]	000b	111 – 2.0% 111 ± 2.0%
	2:0	SSC2_0 [2:0]	000b	
23h	7	FS2_7	0b	FS2_x: PLL2 Frequency Selection[4]
	6	FS2_6	0b	
	5	FS2_5	0b	
	4	FS2_4	0b	
	3	FS2_3	0b	0 – f_{VCO2_0} (predefined by PLL2_0 – Multiplier/Divider value)
	2	FS2_2	0b	1 – f_{VCO2_1} (predefined by PLL2_1 – Multiplier/Divider value)
	1	FS2_1	0b	
	0	FS2_0	0b	

Product Folder Links: *CDCE949 CDCEL949*

Table 8-5. PLL2 Configuration Register (continued)

OFFSET[1]	BIT[2]	ACRONYM	DEFAULT[3]	DESCRIPTION	
24h	7	MUX2	1b	PLL2 Multiplexer:	0 – PLL2 1 – PLL2 Bypass (PLL2 is in power down)
	6	M4	1b	Output Y4 Multiplexer:	0 – Pdiv2 1 – Pdiv4
	5:4	M5	10b	Output Y5 Multiplexer:	00 – Pdiv2-Divider 01 – Pdiv4-Divider 10 – Pdiv5-Divider 11 – reserved
	3:2	Y4Y5_ST1	11b	Y4, Y5-State0/1definition:	00 – Y4/Y5 disabled to 3-State (PLL2 is in power down) 01 – Y4/Y5 disabled to 3-State (PLL2 on) 10–Y4/Y5 disabled to low (PLL2 on) 11 – Y4/Y5 enabled (normal operation, PLL2 on)
	1:0	Y4Y5_ST0	01b		
25h	7	Y4Y5_7	0b	Y4Y5_x Output State Selection[4]	
	6	Y4Y5_6	0b		
	5	Y4Y5_5	0b		
	4	Y4Y5_4	0b	0 – state0 (predefined by Y4Y5_ST0) 1 – state1 (predefined by Y4Y5_ST1)	
	3	Y4Y5_3	0b		
	2	Y4Y5_2	0b		
	1	Y4Y5_1	1b		
	0	Y4Y5_0	0b		
26h	7	SSC2DC	0b	PLL2 SSC down/center selection:	0 – down 1 – center
	6:0	Pdiv4	01h	7-Bit Y4-Output-Divider Pdiv4:	0 – reset and stand-by 1-to-127 – divider value
27h	7	—	0b	Reserved – do not write others than 0	
	6:0	Pdiv5	01h	7-Bit Y5-Output-Divider Pdiv5:	0 – reset and stand-by 1-to-127 – divider value
28h	7:0	PLL2_0N [11:4]	004h	PLL2_0[5]: 30-Bit Multiplier/Divider value for frequency f_{VCO2_0} (for more information, see *PLL Frequency Planning*).	
29h	7:4	PLL2_0N [3:0]			
	3:0	PLL2_0R [8:5]	000h		
2Ah	7:3	PLL2_0R[4:0]			
	2:0	PLL2_0Q [5:3]	10h		
2Bh	7:5	PLL2_0Q [2:0]			
	4:2	PLL2_0P [2:0]	010b		
	1:0	VCO2_0_RANGE	00b	f_{VCO2_0} range selection:	00 – f_{VCO2_0} < 125MHz 01 – 125MHz ≤ f_{VCO2_0} < 150MHz 10 – 150MHz ≤ f_{VCO2_0} < 175MHz 11 – f_{VCO2_0} ≥ 175MHz
2Ch	7:0	PLL2_1N [11:4]	004h	PLL2_1[5]: 30-bit Multiplier/Divider value for frequency f_{VCO1_1} (for more information, see *PLL Frequency Planning*).	
2Dh	7:4	PLL2_1N [3:0]			
	3:0	PLL2_1R [8:5]	000h		
2Eh	7:3	PLL2_1R[4:0]			
	2:0	PLL2_1Q [5:3]	10h		
2Fh	7:5	PLL2_1Q [2:0]			
	4:2	PLL2_1P [2:0]	010b		
	1:0	VCO2_1_RANGE	00b	f_{VCO2_1} range selection:	00 – f_{VCO2_1} < 125MHz 01 – 125MHz ≤ f_{VCO2_1} < 150MHz 10 – 150MHz ≤ f_{VCO2_1} < 175MHz 11 – f_{VCO2_1} ≥ 175MHz

(1) Writing data beyond 50h may adversely affect device function.
(2) All data is transferred MSB-first.
(3) Unless a custom setting is used
(4) The user can predefine up to eight different control settings. In normal device operation, these settings can be selected by the external control pins, S0, S1, and S2.
(5) PLL settings limits: $16 \leq q \leq 63$, $0 \leq p \leq 7$, $0 \leq r \leq 511$, $0 < N < 4096$

Table 8-6. PLL3 Configuration Register

OFFSET[1]	BIT[2]	ACRONYM	DEFAULT[3]	DESCRIPTION		
30h	7:5	SSC3_7 [2:0]	000b	SSC3: PLL3 SSC Selection (Modulation Amount)[4]		
	4:2	SSC3_6 [2:0]	000b			
	1:0	SSC3_5 [2:1]	000b	**Down**		**Center**
31h	7	SSC3_5 [0]		000 (off)		000 (off)
	6:4	SSC3_4 [2:0]	000b	001 – 0.25%		001 ± 0.25%
	3:1	SSC3_3 [2:0]	000b	010 – 0.5%		010 ± 0.5%
	0	SSC3_2 [2]	000b	011 – 0.75%		011 ± 0.75%
32h	7:6	SSC3_2 [1:0]		100 – 1.0%		100 ± 1.0%
	5:3	SSC3_1 [2:0]	000b	101 – 1.25%		101 ± 1.25%
	2:0	SSC3_0 [2:0]	000b	110 – 1.5%		110 ± 1.5%
				111 – 2.0%		111 ± 2.0%
33h	7	FS3_7	0b	FS3_x: PLL3 Frequency Selection[4]		
	6	FS3_6	0b			
	5	FS3_5	0b			
	4	FS3_4	0b	$0 - f_{VCO3\_0}$ (predefined by PLL3_0 – Multiplier/Divider value)		
	3	FS3_3	0b	$1 - f_{VCO3\_1}$ (predefined by PLL3_1 – Multiplier/Divider value)		
	2	FS3_2	0b			
	1	FS3_1	0b			
	0	FS3_0	0b			
34h	7	MUX3	1b	PLL3 Multiplexer:	0 – PLL3	
					1 – PLL3 Bypass (PLL3 is in power down)	
	6	M6	1b	Output Y6 Multiplexer:	0 – Pdiv4	
					1 – Pdiv6	
	5:4	M7	10b	Output Y7 Multiplexer:	00 – Pdiv4-Divider	
					01 – Pdiv6-Divider	
					10 – Pdiv7-Divider	
					11 – reserved	
	3:2	Y6Y7_ST1	11b	Y6, Y7-State0/1definition:	00 – Y6/Y7 disabled to 3-State (PLL3 is in power down)	
	1:0	Y6Y7_ST0	01b		01 – Y6/Y7 disabled to 3-State (PLL3 on)	
					10 –Y6/Y7 disabled to low (PLL3 on)	
					11 – Y6/Y7 enabled (normal operation, PLL3 on)	
35h	7	Y6Y7_7	0b	Y6Y7_x Output State Selection[4]		
	6	Y6Y7_6	0b			
	5	Y6Y7_5	0b			
	4	Y6Y7_4	0b	0 – state0 (predefined by Y6Y7_ST0)		
	3	Y6Y7_3	0b	1 – state1 (predefined by Y6Y7_ST1)		
	2	Y6Y7_2	0b			
	1	Y6Y7_1	1b			
	0	Y6Y7_0	0b			
36h	7	SSC3DC	0b	PLL3 SSC down/center selection:	0 – down	
					1 – center	
	6:0	Pdiv6	01h	7-Bit Y6-Output-Divider Pdiv6:	0 – reset and stand-by	
					1-to-127 – divider value	
37h	7	—	0b	Reserved – do not write others than 0		
	6:0	Pdiv7	01h	7-Bit Y7-Output-Divider Pdiv7:	0 – reset and stand-by	
					1-to-127 – divider value	

Table 8-6. PLL3 Configuration Register (continued)

OFFSET[1]	BIT[2]	ACRONYM	DEFAULT[3]	DESCRIPTION
38h	7:0	PLL3_0N [11:4]	004h	PLL3_0[5]: 30-Bit Multiplier/Divider value for frequency f_{VCO3_0} (for more information, see *PLL Frequency Planning*).
39h	7:4	PLL3_0N [3:0]		
	3:0	PLL3_0R [8:5]	000h	
3Ah	7:3	PLL3_0R[4:0]		
	2:0	PLL3_0Q [5:3]	10h	
3Bh	7:5	PLL3_0Q [2:0]		
	4:2	PLL3_0P [2:0]	010b	
	1:0	VCO3_0_RANGE	00b	f_{VCO3_0} range selection: $\quad$ 00 – f_{VCO3_0} < 125MHz 01 – 125MHz ≤ f_{VCO3_0} < 150MHz 10 – 150MHz ≤ f_{VCO3_0} < 175MHz 11 – f_{VCO3_0} ≥ 175MHz
3Ch	7:0	PLL3_1N [11:4]	004h	PLL3_1[5]: 30-bit Multiplier/Divider value for frequency f_{VCO3_1} (for more information, see *PLL Frequency Planning*).
3Dh	7:4	PLL3_1N [3:0]		
	3:0	PLL3_1R [8:5]	000h	
3Eh	7:3	PLL3_1R[4:0]		
	2:0	PLL3_1Q [5:3]	10h	
3Fh	7:5	PLL3_1Q [2:0]		
	4:2	PLL3_1P [2:0]	010b	
	1:0	VCO3_1_RANGE	00b	f_{VCO3_1} range selection: $\quad$ 00 – f_{VCO3_1} < 125MHz 01 – 125MHz ≤ f_{VCO3_1} < 150MHz 10 – 150MHz ≤ f_{VCO3_1} < 175MHz 11 – f_{VCO3_1} ≥ 175MHz

(1)   Writing data beyond 50h may adversely affect device function.
(2)   All data is transferred MSB-first.
(3)   Unless a custom setting is used
(4)   The user can predefine up to eight different control settings. In normal device operation, these settings can be selected by the external control pins, S0, S1, and S2.
(5)   PLL settings limits: 16 ≤ q ≤ 63, 0 ≤ p ≤ 7, 0 ≤ r ≤ 511, 0 < N < 4096

Table 8-7. PLL4 Configuration Register

OFFSET[1]	BIT[2]	ACRONYM	DEFAULT[3]	DESCRIPTION
40h	7:5	SSC4_7 [2:0]	000b	SSC4: PLL4 SSC Selection (Modulation Amount)[4]
	4:2	SSC4_6 [2:0]	000b	
	1:0	SSC4_5 [2:1]	000b	**Down** $\qquad$ **Center** 000 (off) $\qquad$ 000 (off) 001 – 0.25% $\quad$ 001 ± 0.25% 010 – 0.5% $\quad$ 010 ± 0.5% 011 – 0.75% $\quad$ 011 ± 0.75% 100 – 1.0% $\quad$ 100 ± 1.0% 101 – 1.25% $\quad$ 101 ± 1.25% 110 – 1.5% $\quad$ 110 ± 1.5% 111 – 2.0% $\quad$ 111 ± 2.0%
41h	7	SSC4_5 [0]		
	6:4	SSC4_4 [2:0]	000b	
	3:1	SSC4_3 [2:0]	000b	
	0	SSC4_2 [2]	000b	
42h	7:6	SSC4_2 [1:0]		
	5:3	SSC4_1 [2:0]	000b	
	2:0	SSC4_0 [2:0]	000b	
43h	7	FS4_7	0b	FS4_x: PLL4 Frequency Selection[4]sl
	6	FS4_6	0b	
	5	FS4_5	0b	
	4	FS4_4	0b	
	3	FS4_3	0b	0 – f_{VCO4_0} (predefined by PLL4_0 – Multiplier/Divider value) 1 – f_{VCO4_1} (predefined by PLL4_1 – Multiplier/Divider value)
	2	FS4_2	0b	
	1	FS4_1	0b	
	0	FS4_0	0b	

Product Folder Links: *CDCE949 CDCEL949*

Table 8-7. PLL4 Configuration Register (continued)

OFFSET[1]	BIT[2]	ACRONYM	DEFAULT[3]	DESCRIPTION	
44h	7	MUX4	1b	PLL4 Multiplexer:	0 – PLL4 1 – PLL4 Bypass (PLL4 is in power down)
	6	M8	1b	Output Y8 Multiplexer:	0 – Pdiv6 1 – Pdiv8
	5:4	M9	10b	Output Y9 Multiplexer:	00 – Pdiv6-Divider 01 – Pdiv8-Divider 10 – Pdiv9-Divider 11 – reserved
	3:2	Y8Y9_ST1	11b	Y8, Y9-State0/1definition:	00 – Y8/Y9 disabled to 3-State (PLL4 is in power down) 01 – Y8/Y9 disabled to 3-State (PLL4 on) 10 –Y8/Y9 disabled to low (PLL4 on) 11 – Y8/Y9 enabled (normal operation, PLL4 on)
	1:0	Y8Y9_ST0	01b		
45h	7	Y8Y9_7	0b	Y8Y9_x Output State Selection[4] 0 – state0 (predefined by Y8Y9_ST0) 1 – state1 (predefined by Y8Y9_ST1)	
	6	Y8Y9_6	0b		
	5	Y8Y9_5	0b		
	4	Y8Y9_4	0b		
	3	Y8Y9_3	0b		
	2	Y8Y9_2	0b		
	1	Y8Y9_1	1b		
	0	Y8Y9_0	0b		
46h	7	SSC4DC	0b	PLL4 SSC down/center selection:	0 – down 1 – center
	6:0	Pdiv8	01h	7-Bit Y8-Output-Divider Pdiv8:	0 – reset and stand-by 1-to-127 – divider value
47h	7	—	0b	Reserved – do not write others than 0	
	6:0	Pdiv9	01h	7-Bit Y9-Output-Divider Pdiv9:	0 – reset and stand-by 1-to-127 – divider value
48h	7:0	PLL4_0N [11:4]	004h	PLL4_0[5]: 30-Bit Multiplier/Divider value for frequency f_{VCO4_0} (for more information, see *PLL Frequency Planning*).	
49h	7:4	PLL4_0N [3:0]			
	3:0	PLL4_0R [8:5]	000h		
4Ah	7:3	PLL4_0R[4:0]			
	2:0	PLL4_0Q [5:3]	10h		
4Bh	7:5	PLL4_0Q [2:0]			
	4:2	PLL4_0P [2:0]	010b		
	1:0	VCO4_0_RANGE	00b	f_{VCO4_0} range selection:	00 – f_{VCO4_0} < 125MHz 01 – 125MHz ≤ f_{VCO4_0} < 150MHz 10 – 150MHz ≤ f_{VCO4_0} < 175MHz 11 – f_{VCO4_0} ≥ 175MHz
4Ch	7:0	PLL4_1N [11:4]	004h	PLL4_1[5]: 30-bit Multiplier/Divider value for frequency f_{VCO4_1} (for more information, see *PLL Frequency Planning*).	
4Dh	7:4	PLL4_1N [3:0]			
	3:0	PLL4_1R [8:5]	000h		
4Eh	7:3	PLL4_1R[4:0]			
	2:0	PLL4_1Q [5:3]	10h		
4Fh	7:5	PLL4_1Q [2:0]			
	4:2	PLL4_1P [2:0]	010b		
	1:0	VCO4_1_RANGE	00b	f_{VCO4_1} range selection:	00 – f_{VCO4_1} < 125MHz 01 – 125MHz ≤ f_{VCO4_1} < 150MHz 10 – 150MHz ≤ f_{VCO4_1} < 175MHz 11 – f_{VCO4_1} ≥ 175MHz

(1) Writing data beyond 50h may adversely affect device function.
(2) All data is transferred MSB-first.
(3) Unless a custom setting is used
(4) The user can predefine up to eight different control settings. In normal device operation, these settings can be selected by the external control pins, S0, S1, and S2.
(5) PLL settings limits: 16 ≤ q ≤ 63, 0 ≤ p ≤7, 0 ≤ r ≤ 511, 0 < N < 4096

9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The CDCEx949 device is an easy-to-use high-performance, programmable CMOS clock synthesizer. The device can be used as a crystal buffer, clock synthesizer with separate output supply pin. The CDCEx949 features an on-chip loop filter and Spread-spectrum modulation. Programming can be done through SPI, pin-mode, or using on-chip EEPROM. This section shows some examples of using CDCEx949 in various applications.

9.2 Typical Application

Figure 9-1 shows the use of the CDCEx949 devices for replacement of crystals and crystal oscillators on a Gigabit Ethernet Switch application.
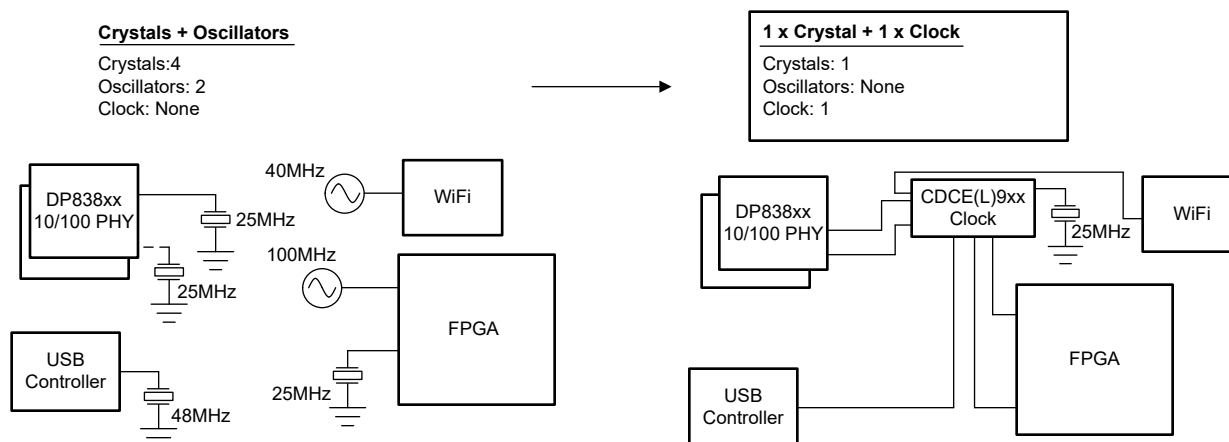
Figure 9-1. Crystal and Oscillator Replacement Example

9.2.1 Design Requirements

CDCEx949 supports spread spectrum clocking (SSC) with multiple control parameters:
- Modulation amount (%)
- Modulation frequency (>20kHz)
- Modulation shape (triangular)
- Center spread / down spread (± or –)
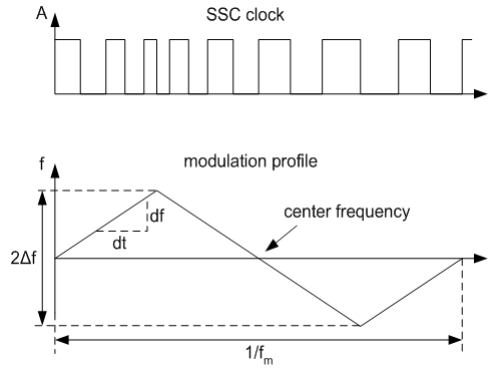
Figure 9-2. Modulation Frequency (fm) and Modulation Amount

9.2.2 Detailed Design Procedure

9.2.2.1 Spread Spectrum Clock (SSC)

Spread spectrum modulation is a method to spread emitted energy over a larger bandwidth. In clocking, spread spectrum can reduce electromagnetic interference (EMI) by reducing the level of emission from clock distribution network.
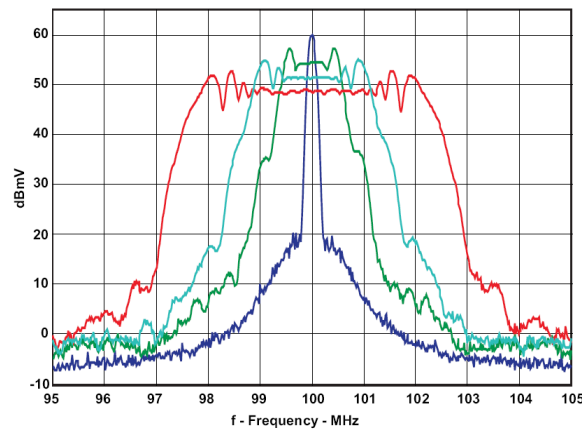
CDCS502 with a 25MHz Crystal, FS = 1, Fout = 100MHz, and 0%, ±0.5, ±1%, and ±2% SSC

Figure 9-3. Comparison Between Typical Clock Power Spectrum and Spread-Spectrum Clock

9.2.2.2 PLL Frequency Planning

At a given input frequency (f_{IN}), use Equation 1 to calculate the output frequency (f_{OUT}) of the CDCEx949.

$$f_{OUT} = \frac{f_{IN}}{Pdiv} \times \frac{N}{M} \tag{1}$$

where

- M (1 to 511) and N (1 to 4095) are the multiplier/divide values of the PLL
- Pdiv (1 to 127) is the output divider

Use Equation 2 to calculate the target VCO frequency (f_{VCO}) of each PLL.

$$f_{VCO} = f_{IN} \times \frac{N}{M} \tag{2}$$

Product Folder Links: *CDCE949 CDCEL949*

The PLL internally operates as fractional divider and requires the following multiplier/divider settings:

- N
- $P = 4 - int(log_2N/M$; if $P < 0$ then $P = 0$
- $Q = int(N'/M)$
- $R = N' - M \times Q$

where

$N' = N \times 2^P$

$N \geq M$;

$80MHz \leq f_{VCO} \leq 230MHz$

$16 \leq Q \leq 63$

$0 \leq P \leq 4$

$0 \leq R \leq 51$

Example:

for f_{IN} = 27MHz; M = 1; N = 4; Pdiv = 2

    → f_{OUT} = 54MHz

    → f_{VCO} = 108MHz

    → $P = 4 - int(log_24) = 4 - 2 = 2$

    → $N' = 4 \times 2^2 = 16$

    → $Q = int(16) = 16$

    → $R = 16 - 16 = 0$

for f_{IN} = 27MHz; M = 2; N = 11; Pdiv = 2

    → f_{OUT} = 74.25MHz

    → f_{VCO} = 148.50MHz

    → $P = 4 - int(log_25.5) = 4 - 2 = 2$

    → $N' = 11 \times 2^2 = 44$

    → $Q = int(22) = 22$

    → $R = 44 - 44 = 0$

The values for P, Q, R, and N' are automatically calculated when using TI Pro-Clock software.

9.2.2.3 Crystal Oscillator Start-Up

When the CDCEx949 is used as a crystal buffer, crystal oscillator start-up dominates the start-up time compared to the internal PLL lock time. The following diagram shows the oscillator start-up sequence for a 27MHz crystal input with an 8pF load. The start-up time for the crystal is in the order of approximately 250μs compared to approximately 10μs of lock time. In general, lock time is an order of magnitude less compared to the crystal start-up time.
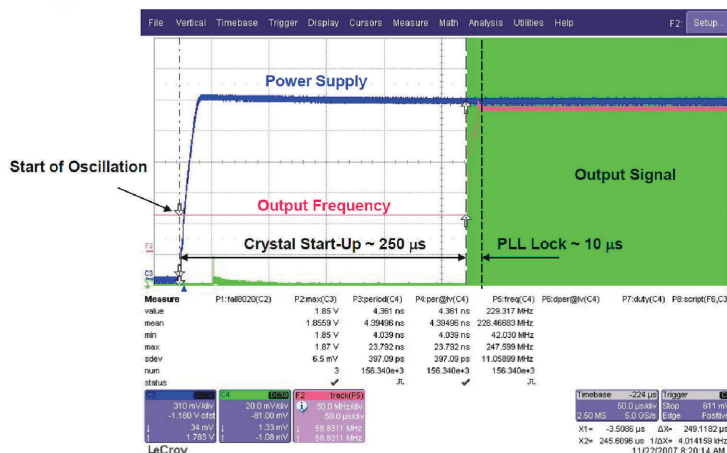
Figure 9-4. Crystal Oscillator Start-Up vs PLL Lock Time

Product Folder Links: *CDCE949 CDCEL949*

9.2.2.4 Frequency Adjustment With Crystal Oscillator Pulling

The frequency for the CDCEx949 is adjusted for media and other applications with the VCXO control input V_{Ctrl}. If a PWM modulated signal is used as a control signal for the VCXO, an external filter is needed.
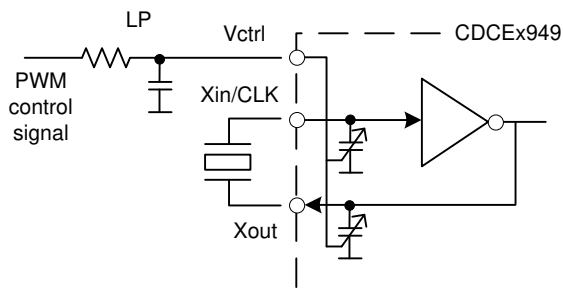
Figure 9-5. Frequency Adjustment Using PWM Input to the VCXO Control

9.2.2.5 Unused Inputs and Outputs

If VCXO pulling functionality is not required, leave V_{Ctrl} floating. Set all other unused inputs to GND. Leave unused outputs floating.

If one output block is not used, TI recommends disabling the that output block. However, TI always recommends providing the supply for the second output block even if the second output block is disabled.

9.2.2.6 Switching Between XO and VCXO Mode

When the CDCEx949 is in crystal oscillator or in VCXO configuration, the internal capacitors require different internal capacitance. The following steps are recommended to switch to VCXO mode when the configuration for the on-chip capacitor is still set for XO mode. To center the output frequency to 0pm:

1. While in XO mode, put Vctrl = Vdd/2
2. Switch from X0 mode to VCXO mode
3. Program the internal capacitors to obtain 0ppm at the output.

9.2.3 Application Curves

Figure 9-6, Figure 9-7, Figure 9-8, and Figure 9-9 show CDCEx949 measurements with the SSC feature enabled. Device configuration: 27MHz input, 27MHz output.

Figure 9-6. f_{OUT} = 27MHz, VCO Frequency < 125MHz, SSC (2% Center)

Figure 9-7. f_{OUT} = 27MHz, VCO Frequency > 175MHz, SSC (1%, Center)
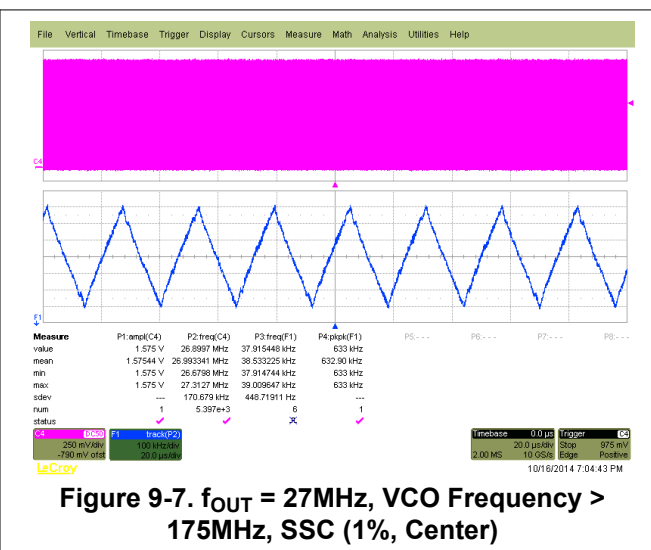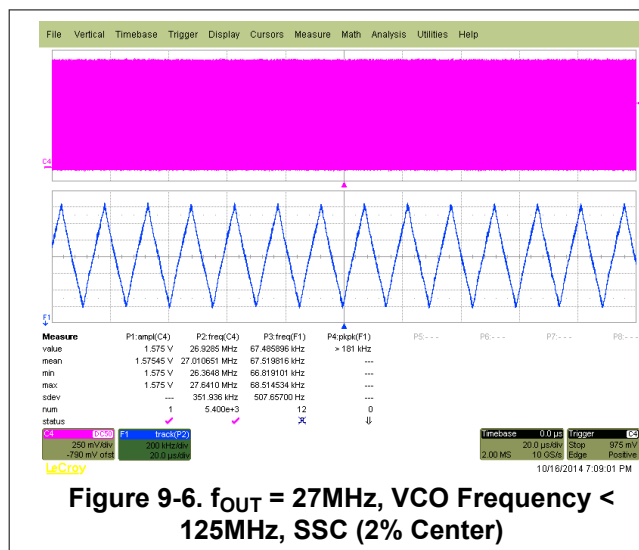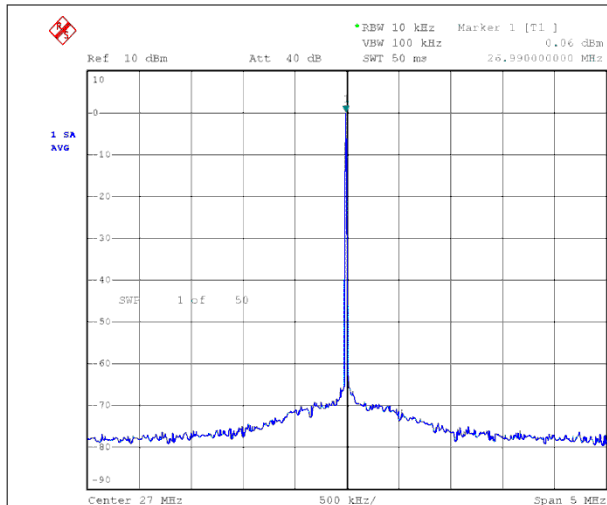
Figure 9-8. Output Spectrum With SSC Off
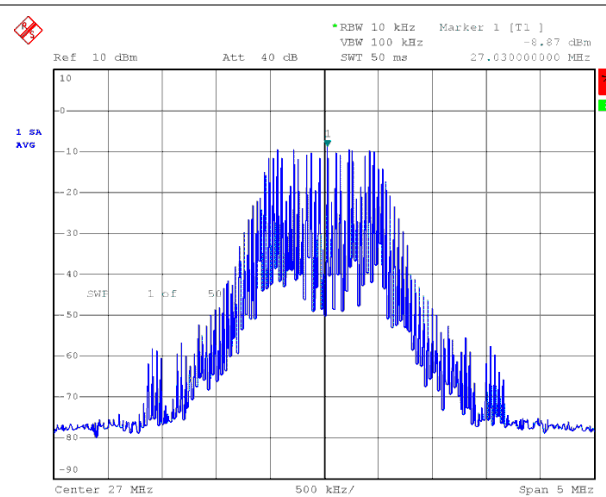
Figure 9-9. Output Spectrum With SSC On, 2% Center

9.3 Power Supply Recommendations

When using an external reference clock, XIN/CLK must be driven before V_{DD} ramps to avoid risk of unstable output. If V_{DDOUT} is applied before V_{DD}, TI recommends keeping V_{DD} pulled to GND until V_{DDOUT} is ramped. If V_{DDOUT} is powered while V_{DD} is floating, there is a risk of high current flowing on the V_{DDOUT}.

The device has a power-up control that is connected to the 1.8V supply. This keeps the whole device disabled until the 1.8V supply reaches a sufficient voltage level. Then the device switches on all internal components, including the outputs. If there is a 3.3V V_{DDOUT} available before the 1.8V, the outputs stay disabled until the 1.8V supply reaches a certain level.

9.4 Layout

9.4.1 Layout Guidelines

When the CDCEx949 is used as a crystal buffer, any parasitics across the crystal affects the pulling range of the VCXO. Therefore, take care placing the crystal units on the board. Crystals must be placed as close to the device as possible so that the routing lines from the crystal terminals to XIN and XOUT have the same length.

If possible, cut out both ground plane and power plane under the area where the crystal and the routing to the device are placed. In this area, always avoid routing any other signal line, as it can be a source of noise coupling.

Additional discrete capacitors can be required to meet the load capacitance specification of certain crystal. For example, a 10.7pF load capacitor is not fully programmable on the chip, because the internal capacitor can range from 0pF to 20pF with steps of 1pF. The 0.7pF capacitor therefore can be discretely added on top of an internal 10pF capacitor.

To minimize the inductive influence of the trace, TI recommends placing this small capacitor as close to the device as possible and symmetrically with respect to XIN and XOUT.

Figure 9-10 shows a conceptual layout detailing recommended placement of power supply bypass capacitors on the basis of CDCEx949. For component side mounting, use 0402 body size capacitors to facilitate signal routing. Keep the connections between the bypass capacitors and the power supply on the device as short as possible. Ground the other side of the capacitor using a low-impedance connection to the ground plane.
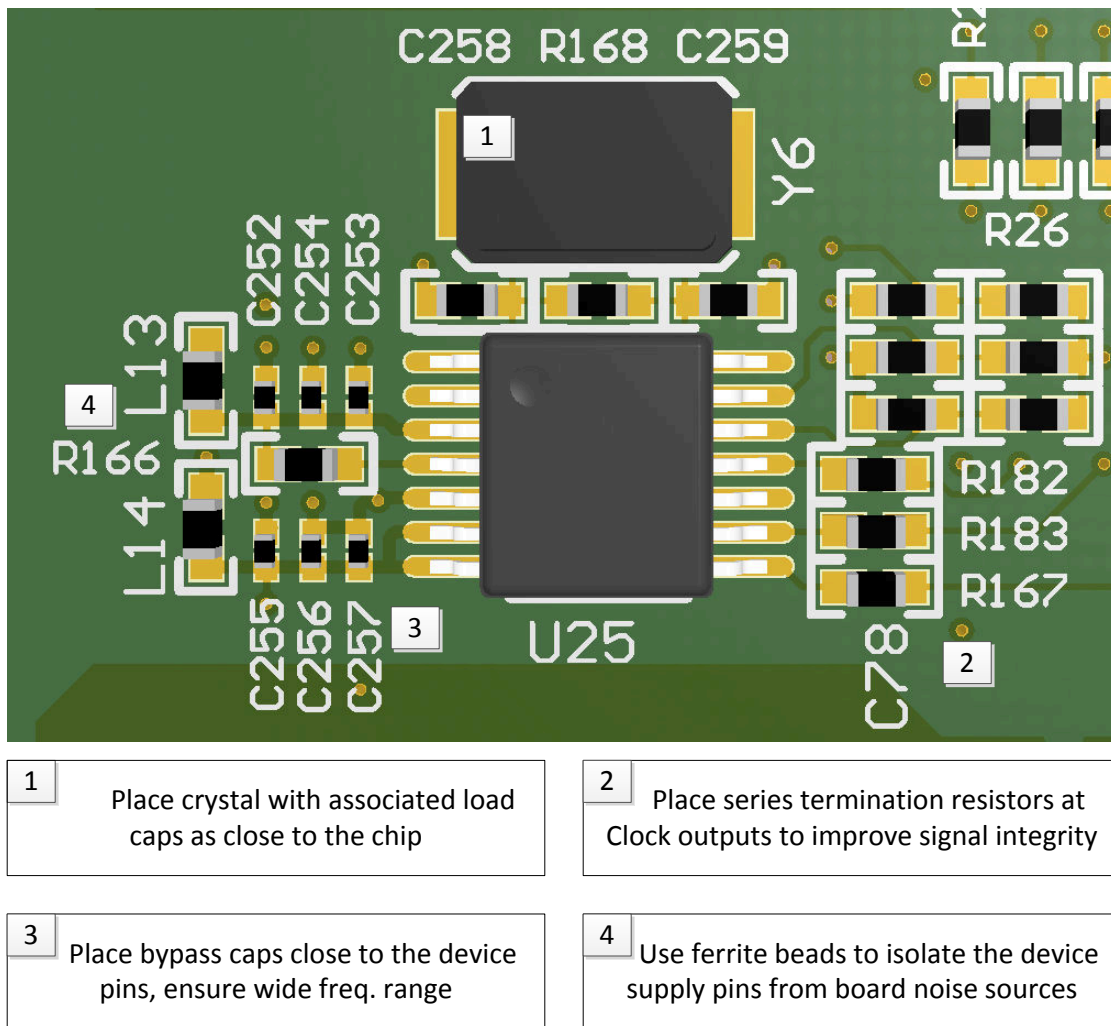
9.4.2 Layout Example

1	Place crystal with associated load caps as close to the chip
2	Place series termination resistors at Clock outputs to improve signal integrity
3	Place bypass caps close to the device pins, ensure wide freq. range
4	Use ferrite beads to isolate the device supply pins from board noise sources

Figure 9-10. Annotated Layout

1. Place crystal with associated load caps as close to the chip
2. Place series termination resistors at Clock outputs to improve signal integrity
3. Place bypass caps close to the device pins, ensure wide frequency range
4. Use ferrite beads to isolate the device supply pins from board noise sounds

10 Device and Documentation Support

10.1 Device Support

10.1.1 Development Support

For development support see the following:

- SMBus
- I^{2}C Bus

10.2 Related Documentation

For related documentation see the following:

Texas Instruments, *Semiconductor and IC Package Thermal Metrics* application note

Texas Instruments, *VCXO Application Guideline for CDCE(L)9xx Family* application note

10.3 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 10-1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
CDCE949	Click here	Click here	Click here	Click here	Click here
CDCEL949	Click here	Click here	Click here	Click here	Click here

10.4 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

10.5 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

10.6 Trademarks

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10.7 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.8 Glossary

TI Glossary   This glossary lists and explains terms, acronyms, and definitions.

11 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGE OPTION ADDENDUM

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CDCE949PW	Active	Production	TSSOP (PW) | 24	60 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CDCE949
CDCE949PW.B	Active	Production	TSSOP (PW) | 24	60 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CDCE949
CDCE949PWG4	Active	Production	TSSOP (PW) | 24	60 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CDCE949
CDCE949PWR	Active	Production	TSSOP (PW) | 24	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CDCE949
CDCE949PWR.B	Active	Production	TSSOP (PW) | 24	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CDCE949
CDCE949PWRG4	Active	Production	TSSOP (PW) | 24	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CDCE949
CDCE949PWRG4.B	Active	Production	TSSOP (PW) | 24	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CDCE949
CDCEL949PW	Active	Production	TSSOP (PW) | 24	60 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CDCEL949
CDCEL949PW.B	Active	Production	TSSOP (PW) | 24	60 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CDCEL949
CDCEL949PWR	Active	Production	TSSOP (PW) | 24	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CDCEL949
CDCEL949PWR.B	Active	Production	TSSOP (PW) | 24	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CDCEL949

(1) Status: For more details on status, see our product life cycle.

(2) Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF CDCE949 :

- Automotive : CDCE949-Q1

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

TUBE

T - Tube height

L - Tube length

W - Tube width

B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CDCE949PW	PW	TSSOP	24	60	530	10.2	3600	3.5
CDCE949PW.B	PW	TSSOP	24	60	530	10.2	3600	3.5
CDCE949PWG4	PW	TSSOP	24	60	530	10.2	3600	3.5
CDCEL949PW	PW	TSSOP	24	60	530	10.2	3600	3.5
CDCEL949PW.B	PW	TSSOP	24	60	530	10.2	3600	3.5

A

6.6 / 6.2 TYP

PIN 1 INDEX AREA

22X 0.65

24

2X 7.15

7.9 / 7.7 NOTE 3

1

12

13

24X 0.30 / 0.19

$\oplus$ 0.1 Ⓜ C A B

B

4.5 / 4.3 NOTE 4

SEATING PLANE

C

0.1 C

1.2 MAX

SEE DETAIL A

(0.15) TYP

GAGE PLANE

0.25

0°-8°

0.75 / 0.50

0.15 / 0.05

DETAIL A
TYPICAL

4220208/A   02/2017

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

24X (1.5)

1

24X (0.45)

SYMM

(R0.05) TYP

24

22X (0.65)

SYMM

12

13

(5.8)

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

SOLDER MASK
OPENING

METAL

EXPOSED METAL

0.05 MAX
ALL AROUND

NON-SOLDER MASK
DEFINED
(PREFERRED)

METAL UNDER
SOLDER MASK

SOLDER MASK
OPENING

EXPOSED METAL

0.05 MIN
ALL AROUND

SOLDER MASK
DEFINED

SOLDER MASK DETAILS

4220208/A   02/2017

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220208/A   02/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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